Chroma

Current Source/ Measure Module 52956 User's Manual

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A regulatory requirement of The People's Republic of China defined by specification SJ/T 11364-2006 mandates that manufacturers provide material contents declaration of electronic products, and for Chroma products are as below:

	Hazardous Substances					
Part Name	Lead	Mercury	Cadmium		•	Polybromodiphenyl
				Chromium	Biphenyls	Ethers
	Pb	Hg	Cd	Cr ⁶⁺	PBB	PBDE
PCBA	×	О	О	0	0	0
CHASSIS	×	O	О	O	0	0
ACCESSORY	×	О	О	0	0	0
PACKAGE	О	О	О	О	0	0

[&]quot;O" indicates that the level of the specified chemical substance is less than the threshold level specified in the standards of SJ/T-11363-2006 and EU 2005/618/EC.

"X" indicates that the level of the specified chemical substance exceeds the threshold level specified in the standards of SJ/T-11363-2006 and EU 2005/618/EC.

- 1. Chroma is not fully transitioned to lead-free solder assembly at this moment; however, most of the components used are RoHS compliant.
- 2. The environment-friendly usage period of the product is assumed under the operating environment specified in each product's specification.

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Revision History

The following lists the additions, deletions and modifications in this manual at each revision.

Date Version Revised Sections

Nov. 2006 1.0 Complete this manual.

June 2007 1.1 Add "Material Contents Declaration".

Modify related contents to comply with the new functions.

Table of Contents

1. Intro	duction	1-1
1.1	Product Description	1-1
1.2	•	
	1.2.1 Opening the Package	
	1.2.2 Checklist	
1.3	Features	1-2
2. Drive	ers Installation	2-1
2.1	Driver CD	2-1
2.2	Installing the Software	
2.3		
	2.3.1 Device Driver Installation on Windows 2000	2-2
2	2.3.2 Device Driver Installation on Windows XP	
2.4	Hardware Verification	
3. Appli	ication	3-1
3.1	The Demand for Laser Diodes	3_1
3.1	Overview of Laser Diode Testing	
3.3	Understanding Laser Diode LIV Testing	
3.4	Test Setup	
	3.4.1 Laser Diode Current Source	
	3.4.2 Optical Power Meter	
	3.4.3 Temperature Controller	
3.5	Dealing with Tunable Laser Diodes	
3.6	Multi-Head Test	
4. Softw	yare	
4.1	Block Diagrams	
4.2	User Programs	
	Operation	
	•	
5.1	=	
5.2		
7	5.2.1 How to Use Soft Front Panel (SFP)	
5.3	Computer Controlled – Simple Automation	5-10
5.4	Sequence Mode	
-	5.4.1 Overview	
	5.4.2 Data Table Creation and Upload	
	5.4.3 Running a Sequence	
7	5.4.4 Downloading the Results Data Table	
	5.4.5 Types of Sequence	3-1/

5.4.6	Data Formats on the Sequencer	5-19
6. DLL Calls	and Example Programs	6-1
6.1 DI	L Calls	6-1
6.1.1	chr52956_init	
6.1.2	chr52956_InitWithOptions	6-3
6.1.3	chr52956_close	
6.1.4	chr52956_SetComplianceVoltage	
6.1.5	chr52956_SetCurrent	
6.1.6	chr52956_SetWireMode	
6.1.7	chr52956_SetOutputRange	
6.1.8	chr52956_ConnectOutput	
6.1.9	chr52956_DisonnectOutput	
6.1.10	chr52956_SetMeasureAverage	6-13
6.1.11	chr52956_SetTriggerSetup	
6.1.12	chr52956_SetMasterMode	6-15
6.1.13	chr52956_SetLocalRelay	
6.1.14	chr52956_SetHWTriggerMode	
6.1.15	chr52956_SetMaximumCurrent	
6.1.16	chr52956_ReadMaximumCurrent	
6.1.17	chr52956_GetRelayThresholds	
6.1.18 6.1.19	chr52956_SetRelayThresholdschr52956_UpdateRelayInfoToEEPROM	0-22
6.1.19	chr52956_ReadVoltage	6 25
6.1.21	chr52956_SequenceRunMaster	
6.1.22	chr52956_SequenceRunSlave	
6.1.23	chr52956_SequenceReset	
6.1.24	chr52956_SequenceWriteHeaderBlock	
6.1.25	chr52956_SequenceReadHeaderBlock	6-30
6.1.26	chr52956_SequenceWriteBlockHeader	
6.1.27	chr52956_SequenceReadBlockHeader	
6.1.28	chr52956_SequenceWriteBlockData	
6.1.29	chr52956_SequenceReadBlockData	
6.1.30	chr52956_SequenceWriteBlockDataArray	
6.1.31	chr52956_SequenceReadBlockDataArray	
6.1.32	chr52956_SetSequenceRunLoopMultiplier	
6.1.33	chr52956_SequenceStatus	
6.1.34	chr52956_reset	
6.1.35	chr52956_error_message	
6.1.36	chr52956_ReadRangeLimit	
6.1.37	Other Driver Functions	6-42
6.2 Err	ror Code	6-43
	ample Program	
7. Hardware	Overview	7-1
	ırdware Block Diagram	
7.1 Па	irdware block Diagraiii	

7.9 7.10	Wire ModeConfiguration	
7.8	Front Panel Connectivity	
7.7	Data Table Format	7-12
7.0	6.2 Measurement Only	
7.0	6.1 Stimulus & Measurement	
7.6	Synchronization	
7.5	Local Bus Interface	
7.4	Trigger Bus Interface	7-7
7.3	3.1 Hardware Overview	7-6
7.3	High Speed Instrument Sequencer (HSIS) Overview	
7.3	2.3 Analogue Section	
7.3	2.2 Sequence Engine Section	7-3
7.3	2.1 Backplane Bus Section	
7.2	Hardware	7-2

1. Introduction

1.1 Product Description

Chroma 52956 Current Source/Measure Module is primarily designed for Laser Diode Test applications. However, it is a versatile instrument and can be used in many other applications. It allows the user to provide an accurate and constant current stimulus required by Laser Diodes and measure the resultant forward voltage drop of the Laser Diode during automated test sequence or manual testing. The user can generate a table of different stimulus values and step rapidly through these using the High Speed Instrument Sequencer (HSIS) functionality of the 52956 module. At each step, the resultant potential can be read back into a table, which can be uploaded from the module to the test systems database. A compliance voltage is programmable on the source to prevent voltage excursions outside programmed limits.

The unit is intended to provide the drive current for a Laser Diode during test or characterization of the device. Multiple units will be required to work in combination when testing / characterizing tunable Laser Diodes.

Compliant to PXI and cPCI Standards

The 52956 Current Source/Measure Module is complying with the latest PXI Revision 2.0 specifications of the PXI System Alliance (PXISA) as well as the CompactPCI specifications as defined by the PCI Industrial Computer Manufacturing Group (PICMG). Both cards are fully compliant with these specifications and as such can be used in either PXI or CompactPCI chassis.

1.2 Opening the Package and Checklist

1.2.1 Opening the Package

Open the 52956 Current Source/Measure Module package carefully and inspect if all hardware are in good condition without any damages and if the Compact Disc is broken or unreadable. If any damage is found and caused the hardware or software application unable to execute, return the product in its original package and contact us.

1.2.2 Checklist

The 52956 kit contains the following items:

- A PXI 52956 Current Source/Measure Module
- A CD containing test software and drivers, and user's manual

1.3 Features

- 1-slot, 3U PXI card
- PXI 1.0 compliant with PXI trigger bus and local bus support
- CompactPCI R PICMG 2.1-R1.0 Hot Swap ready compliant
- Integrate on a master slave basis with other 52956's or other Chroma Photonics Cards
- High Speed Real Time Sequence Engine → 5000 current steps
- Fully floating output allowing star ground connections for multiple units
- 2MB on board memory for data storage and sequence instructions
- Voltage measurement with Kelvin connection
- 16-bit stimulus and measure
- Compliance voltage programmable from 0V to 8V
- Small footprint / PXI Modular Architecture
- Calibration data stored in on-board NV Ram
- Instrument drivers are based on NI-VISA and NI-IVI
- Instrument drivers support NI LabVIEW, NI LabWindows/CVI, Microsoft Visual C++, Microsoft Visual Basic and Borland C++ Builder
- Soft front panel and example program for Windows 2000/XP

2. Drivers Installation

2.1 Driver CD

The driver CD contains the following programs and files:

- Windows 2000, Window XP device drivers
- 52956 soft front panel and program examples
- The instrument drivers and libraries are supported as listed below:
 - NI LabVIEW[®] Ver. 6.1, 7.0, 7.1 & 8.01
 - NI LabWindows/CVI® Ver. 6.0
 - Microsoft Visual C^{++®} Ver. 6.0
 - Microsoft Visual Basic[®] Ver. 6.0
 - Borland C⁺⁺ Builder[®] Ver. 5.0

2.2 Installing the Software

The 52956 instrument drivers are based on National Instruments VISA and IVI. Please install NI-VISA 3.1 and NI-ICP 2.0 (or newer version) before installing 52956 instrument drivers.

Select **Start** and choose **RUN**. Click **Browse** and locate the file "X:\SETUP.exe" (where 'X' is the drive the CD is in), then execute it. The default installation directory is C:\Program Files\Chroma\pxi\52956. It is recommended to use this path as installation directory. Please follow the prompts to complete the installation procedure.

Note: To install the device driver on Windows 2000 or Windows XP, you should log on as the "administrator".

2.3 Installing the Hardware

- Step 1. Make sure the chassis is powered off.
- Step 2. Select a slot in the chassis and install the 52956 Current Source/Measure Module carefully, then secure it with the screws on the panel.
- Step 3. Power the chassis up and boot Windows.

2.3.1 Device Driver Installation on Windows 2000

- Step 4. "Found New Hardware Wizard" will show up after Windows 2000 booting. Click **Next** >.
- Choose "Search for a suitable driver for my device (recommended)".
 Click Next >.
- Step 6. Unselect all "Optional Search locations". Click Next >.
- Step 7. The wizard found "52956 Current Source/Measure Module". Click **Next >**.
- Step 8. Click **Finish** to finish device driver installation on Windows 2000.

2.3.2 Device Driver Installation on Windows XP

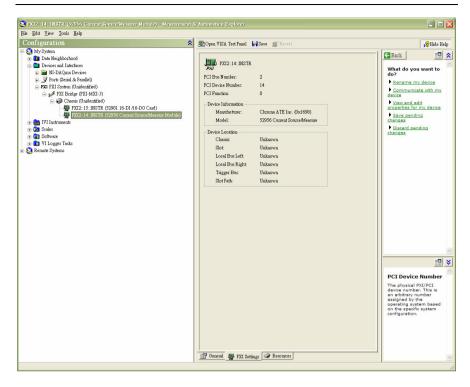
- Step 4. "Found New Hardware Wizard" will show up after Windows XP booting. Click **Next** >.
- Step 5. Choose "Search for a suitable driver for my device (recommended)".
 Click Next >.
- Step 6. Unselect all "Optional Search locations". Click Next >.
- Step 7. The wizard found "52956 Current Source/Measure Module". Click **Next** >.
- Step 8. Click **Finish** to finish device driver installation on Windows XP.

2.4 Hardware Verification

Follow the description below to verify if the 52956 is properly installed and working.

National Instruments VISA Interactive Control (MAX)

The National Instruments software application, VISA Interactive Control, can be used for verification. This is a program to identify the installed VISA resources including PXI resources as shown below.



VISA Resources

In this example, there is one PXI module installed. The 52956 module is the only PXI module slot in the chassis and is identified as PXI2::14::INSTR.

3. Application

Chroma 52956 Current Source/Measure Module can be used in many different applications where multiple stimuli and or measurements are required to be taken over a short period of time. As with any process, the shorter the time taken, the more efficient the process is. One application for this product is testing & characterization of Laser Diodes & Tunable Laser Diodes. This application section is prepared by Dr Gerald Farrell.

3.1 The Demand for Laser Diodes

In the last few years the demand for more and more bandwidth in telecommunications networks has lead to an ever increasing demand for multi channel Dense Wavelength Division Multiplexed (DWDM) systems. At present vendors are offering systems that can provide more than 100 channels, with the promise of even higher channel counts in the near future. Each channel uses a laser diode as a source and thus a consequence of the increased demand for bandwidth is that the volume of laser diodes being produced for telecommunications applications is increasing faster than ever before. In turn this means that manufacturers of laser diodes not only need economic and accurate laser diode testing, but this testing must take place at high speed.

This article provides an overview of laser diode testing at manufacturer, highlighting the tests that need to be carried out and also describing a typical ATE based laser diode test setup.

3.2 Overview of Laser Diode Testing

A completed Laser Diode Module (LDM) will typically contain several other components, such as a back-facet power monitor photodiode and possibly a thermoelectric cooler. As a result the completed module is complex and requires testing at several stages during assembly. Coupled to the increasing demand for laser diodes the need for multiple testing stages means that speed of testing, while retaining accuracy, is now a critical issue.

Laser diode testing takes place from the raw laser chip stage to the completed module stage. The typical testing stages for a telecommunications laser diode

are shown in Figure 3-1 below.

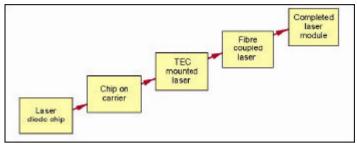


Figure 3-1 Laser Diode Testing Stages

The higher up the test stage the more expensive the test equipment involved and the cost of rejecting faulty laser diodes. DC testing, called Light-Current-Voltage (LIV) testing, provides an initial test which can typically measure several key laser parameters. LIV testing can also eliminate below-par lasers which could ultimately fail higher up the testing chain, where failure is more expensive.

3.3 Understanding Laser Diode LIV Testing

Semiconductor laser diodes are current driven devices and as the name implies LIV testing involves altering the drive current while measuring the optical output power and the forward voltage across the laser. By measuring the optical output power and forward voltage over a range of input currents an LIV characteristic can be built up which when analyzed can yield valuable information about the laser diode.

Typical voltage-current (VI) and light-current (LI) characteristics are shown in Figure 3-2. Optical output power can measured directly using an optical fiber aligned precisely with the laser diode output facet. Additionally all laser diode modules also incorporate a Back-Facet Monitor (BFM) photodiode, which can also be used to monitor optical power levels.

When analyzed a LI characteristic can provide:

- The value of the laser threshold.
- Evidence of undesirable "kinks" or non-linearities in the laser characteristic that can point to inherent problems that will mean rejection of the device. For example a kink can be indicative of "mode hopping" in

the optical spectrum. Mode hopping is very undesirable, particularly for DWDM applications and while it can be detected at after testing stages it is more economic to detect evidence of mode hopping at an earlier test stage.

• The slope efficiency of the laser, that is the rate of change of optical power with drive current. Ideally slope efficiency should be a constant above threshold up to a saturation point.

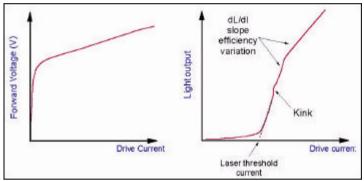


Figure 3-2 Laser VI and LI Characteristics

Analysis of the LI portion of LIV data typically involves applying a numerical differentiation algorithm to the data. Differentiating the LI data results in a graph where the slope of the original LI characteristic is now plotted as a function of the drive current level. This process accentuates changes, such as the change in light level at threshold or at kinks. A typical differentiated LI characteristic is shown in Figure 3-3.

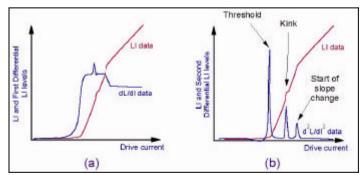


Figure 3-3 - Differentiated LI Characteristics (First (a) and Second (b))

In Figure 3-3(a) the original LI data and the first differential of the LI data are shown. By analyzing this data the slope efficiencies above threshold can be found in mW/mA. A typical minimum value for a laser used within a DWDM transceiver is about 0.07 mA/mW. The kink is also more obvious, showing up as a small spike.

Taking the second differential of the LI data results in the graphs in Figure 3-3(b), with the original LI data again shown for reference. The threshold current is clearly indicated and can be estimated accurately. The location of the kink is also obvious as is the start of the change in the slope efficiency that also occurs.

The LIV characteristics may be measured at several temperatures and at temperature extremes to ensure compliance with specified temperature performance. Laser diodes are very sensitive to temperature changes. The laser threshold increases with temperature, while the slope efficiency decreases. A laser threshold that rises excessively with increasing temperature may point to a sub-standard device or assembly. Measuring the LIV characteristic at several temperatures, results in a substantial amount of data, when a numerical differentiation algorithm is applied to each LI data set. From this data the temperature coefficient of the threshold current (mA/°C) and of the slope efficiency (mW/mA/°C) can be found and compared to maximum permitted values.

The BFM photodiode itself may also be characterized during LIV testing to investigate its IV characteristic and the linearity of its output current as a function of the optical power level, as well as other parameters such as dark current. Higher than normal dark currents could point to defects within the photodiode or a surface leakage problem. The dark current level for a typical DWDM laser module is about 200 nA.

Finally many manufacturers of laser diodes for DWDM applications are offering more complex 'tunable' devices. A number of different designs exist which offer tunability, either over a relatively narrow range of about 5 nm or in the case of some of the newer offerings, over the whole 'C' band. All of the 'tunable' designs to date are multi-section laser diodes and are in effect multiple 'current controlled' devices. As a result the LIV testing requirements are expanded exponentially due the interdependence of one section on the next.

3.4 Test Setup

To carry out an LIV test on a laser diode a set up similar to that shown in Figure 3-4 is required. For volume laser production this set up forms the core of a complete automatic test equipment (ATE) environment. Carrying out the LIV tests in the shortest possible time means that all of the individual pieces of equipment need to be optimized for speed.

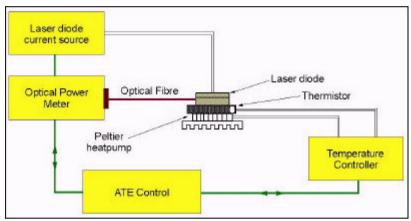


Figure 3-4 Laser Diode LIV ATE Testing

3.4.1 Laser Diode Current Source

A precise laser diode current source is critical for LIV ATE testing. Any good laser diode current source must both drive and protect the laser diode under test. Protection means that external current and voltage spikes must not reach the laser diode. Current drive must be wide ranging and accurate, that is it should be possible to step the laser current from 0 to about 500 mA typically with increments of 0.5 mA. A DWDM laser will have a typical threshold of 10-30 mA with LI characterization to about three to five times the threshold value or even higher. Lower threshold lasers, such as Vertical Cavity Surface Emitting Lasers (VCSELs), will require a lower maximum current but a current increment as low as 0.1 mA. The sweep across the laser current range must also take place quickly covering the appropriate current range with 100 or more discrete current values in 1-2 seconds.

The current source must also be capable of measuring the forward voltage on the laser accurately with milli-volt resolution, at a speed fast enough to track source current changes.

3.4.2 Optical Power Meter

An optical power meter is needed to measure optical power levels. It may also be used to facilitate the automatic alignment of a test fiber with the laser diode output facet. Typically the power meter will need a wide dynamic range from -70 dBm to +3 dBm or higher. A high speed LIV ATE setup demands power meters capable of at least matching the incremental speed of the current source typically taking measurements at intervals of 1 ms or less.

It is worth noting that in setting up an LIV ATE test any instrument induced non-linearities may be misinterpreted as kinks, leading to false rejections of lasers. For example many power meters utilize auto ranging, which is a useful way of achieving a large dynamic range. However auto-ranging can lead to small power steps at the range switch points which can be misinterpreted as kinks. One approach is to force the power meter to remain on a fixed range if possible, however this may not be possible where the power range exceeds two decades.

3.4.3 Temperature Controller

Precise temperature control is also needed. Lasers are temperature controlled using a combination of a Peltier cooler element (a TEC, "Thermoelectric Cooler") and a feedback temperature monitor such as a thermistor or semiconductor device. Control to within at least 0.05 °C is needed and depending on the application the temperature test range may be from -10 °C to +50 °C or wider. While absolute temperature stability is important, with long-term stability values of ± 0.01 °C or better available, it is the overall speed of response that is of most significance for LIV testing of laser diode at manufacture.

Ideally a temperature controller should be able to bring a laser diode to a set temperature as rapidly as possible but with a very fast settling time once the set temperature is reached and this requires sophisticated control. The most common form of control is a PID loop which derives is name from the presence of Proportional Gain (P), Integration (I) and Differentiation (D), in the control

loop. Typically the PID loop is implemented digitally to allow for ease of programming. Programming allows the dynamic response of the controller to be optimized by independently setting the gain, integration time and the differential time constant.

PID control is superior form of control by comparison with a simple PI loop control. This is because introducing the derivative term reduces the settling time after a step change in temperature and thus reduces the overall measurement time. PI based laser diode temperature controllers are only adequate for applications where overall temperature response speed is not a critical factor.

BFM Photodiode Measurements

An LIV ATE setup may also incorporate a means of measuring the BFM photodiode voltage and output current. The current range required will depend on the measurements to be carried out, but measurement up to 10 mA or higher may be required. Measuring dark current on the other hand will require sub-nA grade current measurement. It should also be remembered that BFM photodiode dark current is strongly influenced by temperature, so that such measurements may need to be repeated at several temperatures.

Given the wide dynamic range required for BFM photodiode current measurement typically this is best carried out using an optical power meter which allows for direct connection of the BFM. The reason for this is that optical power meter front ends are designed from the outset to cater for very low current levels in the pA range. Most conventional multi-meters are not designed for this, with lowest ranges in the μA region.

3.5 Dealing with Tunable Laser Diodes

The multi-section nature of these devices calls for an LIV ATE setup that incorporates multiple current sources and can provide precise synchronization between these sources. In these cases by definition the LIV scans are both lengthy and complex. A four sections laser diode module may require many 10,000's of individual measurements in comparison to a few hundred for a single section laser. Therefore a tunable laser LIV ATE setup should be able to run at least 100K tests with precise timing between the various elements and with storage for all the results in 'Real Time'. It should also be capable of transferring these results to the controlling computer in either single or block form without causing the test process to slow.

3.6 Multi-Head Test

As laser diode manufacturers seek to improve efficiency, the modern LIV ATE structure should be easy to expand from a single laser test station to one that can, for example, deal with four laser diodes at one time. Thus the LIV ATE design needs to be scalable to suit present and future requirements. The existing infrastructure should have enough capacity to house the additional resources. It goes without saying that a 'single head' LIV ATE should occupy very little space but also that the expansion to multiple heads should demand as little extra space as possible. Space is always at a premium in these cases.

The Complete System

All of the elements above must be combined to function in a complete ATE environment, which controls, retrieves and stores the data as quickly as possible. PX Instrument Technology is developing a complete range of modules for ATE based laser LIV testing based on the PXI standard. This range will compliment the company's existing broadband PXI-based optical switching products.

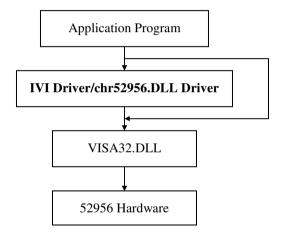
PXI is a very beneficial platform for characterizing lasers as it offers high speed and excellent synchronization facilities that allow all of the elements of an LIV system to optimally function together.

4. Software

4.1 Block Diagrams

In the figure below, User Program is the application running at the upper level of the system. The user program calls for supporting functions, e.g... chr52956_init (ViResc resourcename,,,ViSession *vi).

The instrument driver communicates to hardware through standard VISA calls.



4.2 User Programs

User applications can be written by standard programming languages such as LabVIEW, LabWindows/CVI, Visual Basic, Visual C⁺⁺, and Borland C⁺⁺ Builder. An example written in C of it can be seen in section 6.3 *Example Program*.

5. Basic Operation

Chroma 52956 Current Source/Measure Module can be used as a simple device for providing a current stimulus and/or voltage measurement, which is either program controlled or manually controlled. It can also be used as a more complex device, which automatically sequences through a range of stimuli or measure or combined stimuli and measurement steps.

Once the module(s) is/are correctly installed, the user should have access to functions which allow them to use the module(s).

5.1 Block Diagrams

The following figure shows the device operation flow. Users need to use programs to control the instrument.

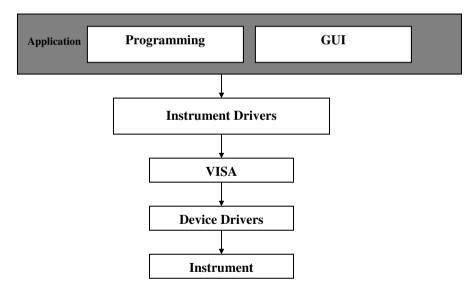


Figure 5-1

5.2 Manual Mode

A Soft Front Panel program is provided which allows the user to manually control all of Chroma 52956 modules which are installed in their system. The **SFP52956.exe** is located in the directory specified during the installation process (usually in C:\Program Files\Chroma\PXI\52956\ SFP52956.EXE).

5.2.1 How to Use Soft Front Panel (SFP)

SFP will show the dialog to select a 52956 as follows.

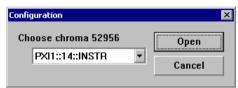


Figure 5-2 Configuration Dialog

Choose a module as you need and click **Open** to enter main panel.

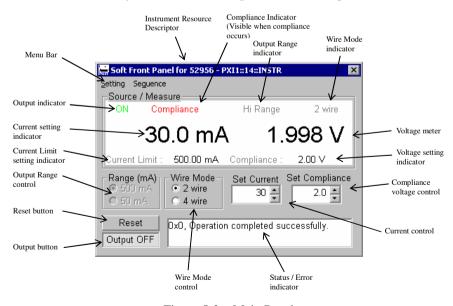


Figure 5-3 Main Panel

Main Panel function description:

□ soft Front Panel for S2956-PXII:14:INSTR - Instrument Resource Descriptor Indicate which instrument is currently be used.

Setting Seguence - Menu Bar

Open module setting and sequence function dialog.

ON / OFF - Output indicator

The symbol ON means output ON, and OFF means output OFF.

30.0 mA - Current setting indicator Indicate the actual current value that has been set.

1.998 V - Voltage meter

The voltage measurement value of the UUT.

Current Limit: 500.00 mA - Current Limit setting indicator Indicate the current limit setting value. Current Limit can be set in the Module Setting dialog.

Compliance: 2.00 V - Voltage setting indicator Indicate the compliance voltage setting value.

2 wire - Wire Mode indicator

Indicate the wire mode setting. 2 wire is 2 wire mode, and 4 wire is 4 wire mode.

HiRange - Output Range indicator

Indicate currently range select. HiRange is $0 \sim 500 \text{mA}$, and Low Range is $0 \sim 50 \text{mA}$.

Compliance - Compliance Indicator

Indicate if the compliance condition is occurred.

Note: The symbol is visible only if the compliance condition is occurred, or it is invisible.

Range (mA) • 500 mA

- Output Range control

Click the radio button can change the output range immediately.

Note: The Output Range Control will be disabled when the output is ON.

```
Wire Mode control
```

Click the radio button can change the wire mode immediately.

Edit the current value and click Enter can change the current setting. Or you can click the increment and decrement button to set current value.

```
set compliance voltage control
```

Edit the voltage value and click Enter can change the voltage setting. Or you can click the increment and decrement button to set voltage value.

```
Reset button
```

Reset the instrument to the initialized state.

```
Output ON - Output button
```

Control the output ON/OFF. When the label of the button is "Output ON", it means you can click the button to make the module "output ON", and vice versa.

```
0x0, Operation completed successfully.

- Status / Error Indicator
```

Show error code and its description here.

5.2.1.1 Module Setting Dialog

Figure 5-4 shows the Module Setting Dialog. You can set several parameters on this dialog.

Note: Every setting is changed only when the **Apply** button is clicked.



Figure 5-4 Module Setting Dialog

Module Setting Dialog function description:

Current Limit setting

Modify the current limit value. After clicking Apply, the range of the current value you can set in the main panel cannot exceed this value.

□ Enable HW Trigger - Enable Hardware Trigger

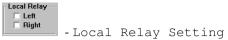
Check it to make hardware trigger enabled. Uncheck it to make hardware trigger disabled.

Trigger Setup: TRIG None - Trigger Setup Selection
Select the trigger setup. Possible selections are listed below:

Setup	Purpose
TRIG None	None
TRIG0 IN	
TRIG1 IN	For Slave
TRIG2 IN	Tor Stave
TRIG7 IN	
TRIG0 OUT	
TRIG1 OUT	For Master
TRIG2 OUT	Toi Mastei
TDIG7 OUT	

Measure average: 32 - Measure Average Setting

Select the measure average times that the instrument used in every voltage measurement. It can only be 1, 2, 4, 8, 16, 32, 64 or 128. For example, if 32 has been chosen, the instrument will take 32 measurements then return the averaged value.



Select the local relay to be connected or not. Check it will make the selected relay to be connected.

```
Master Mode - Master Slave - Master Mode Setting
```

Click the radio button to select Master mode or Slave mode.

5.2.1.2 Sequence Function Dialog

In the Sequence Editor Dialog, you can edit the format of the sequence table, block number and the elements belong to each block. Also you can read back the measured voltage value after the sequence engine running successfully.

Note: About the function of Sequence table, please refer to section **5.4 Sequence Mode** for detailed information.



Figure 5-5 Sequence Editor Dialog

Sequence Editor Dialog function description:



Click the radio button to switch the function. This dialog can be a sequence editor or a sequence data reader. If the sequence never runs and stops

successfully since this program starts, the Retrieve Data option will be disabled.

```
Number of Block: 2 - The Number of Blocks
```

Change the number of blocks in the sequence table. You can enter the block number then click "Enter", or just click the increment or decrement arrows to change the number. Once the number is changed, the grid will increase or decrease its size. You can key-in the element count, source delay time and measure delay time of each block.

```
Sequence behavior - Sequence Behavior Selection
```

The sequence has three behavior types. Source only, measure only and both. Check the behaviors you want here.

```
Sequence Engine Control

Run Master Sequence engine is stopped!

- Sequence Control and Status
```

Click **Run Master** (**Run Slave**) button to start the sequence engine. The status of sequence engine will be shown here. The status description listed below:

- 1. Sequence engine is stopped! It means the sequence engine is completed.
- 2. Sequence engine is running... It means the sequence engine is running.
- Sequence engine is stopped with error! It means the sequence engine is stopped with some error occurred.

Each row represents a block and possesses columns to key-in block information. As shown in Figure 5-6, when clicking the right mouse button in the row, a popup menu will be shown. Select Edit block will open an element edit dialog. The Element Editor Dialog is shown in Figure 5-7.

```
Apply Button
```

After finishing edit sequence table, you can click **Apply** button to write it into instrument, and the **Run Master** (**Run Slave**) button will be enabled.

```
- Close Button
```

Click close button will close the sequence editor dialog. Everything will be stored until the program is closed. So you still can continuously edit the sequence table when the sequence edit dialog is opened again.

Stop - Stop Button

Stop the sequence engine when it is running.

0x0, Operation completed successfully.

- Status / Error Indicator

Show error code and its description here.



Figure 5-6 Click the Right Mouse Button in the Sequence Editor Dialog



Figure 5-7 Element Editor Dialog

After running the sequence engine, click the Retrieve Data radio button in the Function Switch group can turn the edit grid into read sequence data grid. It is shown in Figure 5-8.

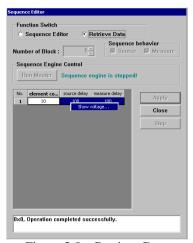


Figure 5-8 Retrieve Data

Click the right mouse button in the row, a popup menu will be shown. Select Show Voltage will open Element Editor dialog again, but this time it shows the measured voltage data as shown in Figure 5-9.

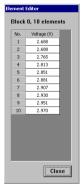


Figure 5-9 The Measured Voltage Data

5.3 Computer Controlled – Simple

Automation

It is possible for the user to develop applications to provide simple automation to the Chroma 52956 module(s). Using this method, commands are sent from the system PC controller via the PCI bus to the target module and which are instantly executed by the target module. Using this method, the user can enable the output, change output settings such as current range, value, etc. However, timing is computer and bus dependent and timing between output settings is difficult to guarantee.

5.4 Sequence Mode

In Sequence Mode, the user loads the memory of Chroma 52956 module with a pre-defined table containing a series of output setting values and configuration settings. When the sequencer is run, it steps through each element of the table and performs an action depending on the configuration setting of the FORMAT byte. The FORMAT byte is the fourth byte of the table and sets up the module as a measure module only, a source module only or a combined source /measure module.

The operation of the sequence while running is totally independent of the system controller and therefore timing restrictions of the PCI bus and System controller are not applicable.

Once the sequence has completed, the contents of the table in the module memory can be uploaded to a file on the System PC and its contents analyzed.

One or more modules using the sequencer functionality may run synchronously. Section 4 of this manual explains some of the theory of the operation of the sequencer. However, there are some setup considerations which must be taken into account before implementing this.

- When two or more modules are used as part of a sequence group, they
 must be immediately adjacent to each other. There can be NO empty
 slots between modules in the same sequence group.
- One of the modules must be designated to run in master mode and the remainder to run in slave mode.

- If the group of modules span over two or more PCI bus segments, the trigger bus bridge must be switched on to drive the trigger bus signal in the correct direction.
- Each module in the group must use the same trigger bus line.
- The group must be linked together using the left & right Local Bus relays as appropriate.
- If more than one sequence group is used on a system bus, different trigger bus lines must be used for each sequence group.
- If the different sequence groups are immediately adjacent to each other, the local bus relays between the adjacent modules in the two groups must be disconnected

5.4.1 Overview

Sequencing on the Chroma Photonic range of modules which support HSIS functionality consists of a number of PXI modules, all linked via PXI synchronization lines, one module operating as a master with all other modules operating as slaves

Some modules may operate as single or dual source instruments, some may operate as single or dual measure instruments and some may operate as a combination of both.

Each sequence step will usually consist of a source function or a measure function, however it is possible for some modules to perform a source and a measure function or even two measure functions within a single sequence step.

The functionality of a module is defined using the FORMAT byte parameter, which is stored in the sequence header block. While a module may be able to perform both source and measure functions, the format parameter defines which are used during the sequence.

Because all the sequence modules are synchronized at step level, the number of functions performed during a sequence step should be identical throughout all modules. For example, if one module is performing two measurements per step, and one module is only performing one source per step, the module performing the source function should include an additional function, usually a NULL function. This will aid debug, and clarify the memory data.

Although it would be typical to run a number of modules in a sequence group, a single module can also perform a sequence. In this instance, the module

would be configured as the master and would not require the use of the synchronizing signals.

The complete sequence table loaded into a modules memory is broken down into a number of blocks, each with its own timing characteristics, and each able to have up to 216 steps.

Each block would be used to hold similar sequence steps, all having a common timing requirement, therefore a typical sequence might require one block for executing six sequence steps of 1mS, one block for executing a single step of 10mS, followed by an additional block of 1mS steps

This single step block in this example would allow a discharge or settle to be introduced.

The RAM is accessed in a sequential manner using only the commands sequence reset and sequence read and write which auto increment the address counter. Therefore the address counter on each module MUST BE reset prior to the upload of data, the running of a sequence or the download of data

Sequencing on Chroma 52956 is achieved by executing a pre-defined number of "blocks" contained within the on board RAM. Each "block" contains group timing information and depending on the module function, a number of source or measurement data, each referred to as an element.

The requirement for individual delays will ultimately determine the number of blocks required. It is only when a delay changes that a new block is required. The option exists of course to break up output patterns into smaller manageable chunks

A typical example is one where three different data patterns are required, each one being spaced by a single element block, which ensures that the current settles to a stable value before the next ramp starts. The individual ramps can have any number of steps, and providing all require the same timing, can be placed in the same block.

Block #	Element #	Function	Timing per step
1	1	Set output to 5mA	10mS
2	250	Set a Pattern-1 250 values	1mS
3	1	Set an O/P of 0mA	5mS
4	1000	Set a Pattern-2 250 values	50uS
5	1	Set an O/P of 0mA	5mS
6	20000	Set a Pattern-3 20000 values	1mS
7	20000	Set a Pattern-4 20000 values	2mS
8	1	Set an O/P of 0mA	10mS

Table 5-1 Example of Data Table Block Overview

The output from the data given in the above table would be as follows:

10mS at 5mA, 250mS of Pattern-1, 5mS at 0mA, 50mS of Pattern-2, 5mS at 0mA, 20 seconds of Pattern-3, 40 seconds of Pattern-4, and finally 10mS of 0mA.

A sequence is therefore performed by:

- 1. Uploading some data
- 2. Configuring the module
- 3. Running the sequence
- 4. Waiting for sequence completion
- 5. Downloading the data

5.4.2 Data Table Creation and Upload

The data table that is loaded into the module(s) memory can be created from a user program or extracted from a file. Method of data table creation is left up to the user. One method is to create a CONFIG.DAT file, which initializes the system and configures all modules. Before any data may be written, the sequence must be reset using the call:

chr52956_SequenceReset()

5.4.2.1 The Block Header

The block header defines how many elements exist within the block, what timing is used for both the source and the measure cycle, and a specific control word unique to each module.

The block header is read and written using the calls:

```
ViStatus _VI_FUNC chr52956_SequenceWriteBlockHeader (ViSession vi, ViUInt16 count, ViUInt16 sourceDelay, ViUInt16 measureDelay);

ViStatus _VI_FUNC chr52956_SequenceReadBlockHeader (ViSession vi, ViUInt16 *count, ViUInt16 *sourceDelay, ViUInt16 *measureDelay);
```

5.4.2.2 The Block Data

The block data consists of the individual sequence elements, each of which is defined by the data format word. i.e. if the format specifies both source and measure functionality, the single element will consist of both a source value and a measure value. If the format specifies only a source function, the single element will consist of only a single source value

The actual data stored in the block is in the form of signed 16 bit integers suitable for the on board DACs, and ADC's, however data is passed as either ViReal64 "double" format or ViUInt16 "unsigned integer" format.

The block data is read and written using the calls:

```
ViStatus _VI_FUNC chr52956_SequenceWriteBlockData (ViSession vi, ViUInt16 count, chr52956SequenceData *sequenceData, ViUInt16 format);

ViStatus _VI_FUNC chr52956_SequenceReadBlockData (ViSession vi, ViUInt16 count, chr52956SequenceData *sequenceData, ViUInt16 format);
```

Data is passed to and from the functions as a group of arrays of either ViReal64's or ViUInt16's. A specific data structure of the type chr52956SequenceData is used for this data transfer and consists of four pointers, source1, source2, measure1, and measure2.

Either an array of values can be created, with this array address being assigned to the relevant pointer, or a heap block can be directly allocated to the pointer.

Any unused pointers must be set to NULL or 0, to declare them as unused.

These arrays along with the data format bytes are used by the two functions for data transfer. It is important that the format byte used in the header block function matches that of the format byte used by the block data function.

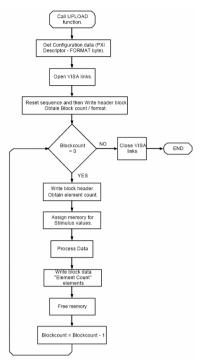


Figure 5-10 Block Diagram Showing Typical Steps Required to Load a Sequence

It should be noted that due to the way in which the sequencer runs, the first item of measure is performed before the first item is sourced, thereby causing a NULL measure item at the start of a block.

In a similar way, the last item of source is performed after the last measurement has taken place, thereby causing a NULL source at the end of a block.

This source can be used by either the previous source value or a zero value, or the next blocks initial source value. The initial NULL measure value of the next block will in fact use the final NULL source value of the previous block.

5.4.3 Running a Sequence

Before a sequence can be run, the module must be configured and the sequence engine reset.

Configuration would consist of setting either 2 wire mode or 4 wire mode, enabling current outputs, as well as connecting the synchronizing signals (Local and Trigger bus) between adjacent boards and setting up the module for external IO (via AUX connector) or internal IO triggered.

The sequence is started using the chr52956_SequenceRunSlave() and chr52956_SequencRunMaster() calls. The 'Run Slave' call should always be sent to all slave modules in a group before the 'Run Master' call is used. If there is only one module in a group, the 'Run Slave' call is not required. Once the Run Master command is sent, the sequence will commence. Only the synchronizing lines are able to externally control the master, hence why the slaves are started first.

If the inter-module links (Local bus and Trigger bus routing) are not made, nothing will externally stop the master module, and it will promptly finish its sequence without regard for any other boards. The sequencer is executed using the calls:

```
ViStatus _VI_FUNC chr52956_SequenceRunMaster (ViSession vi);
ViStatus _VI_FUNC chr52956_SequenceRunSlave (ViSession vi);
```

There is no status signal sent to the system controller from the modules to let it know if the sequence is completed, however once the sequence has completed one of two bits will be set in the status register. One is for sequence done, one for sequence error.

By polling this bit, the user can find out if the sequence has completed successfully or if an error has occurred. If all the modules were set up correctly, every module in the sequence will enable its complete bit, otherwise there is an error within the sequence data or module setup.

5.4.4 Downloading the Results Data Table

Before any data can be downloaded from the modules, the sequence must be reset using the call chr52956_SequenceReset().

The data stored in the block is in the form of signed 16 bit integers suitable for the on board ADC's, and is passed as either ViReal64 "double" format or ViUInt16 "unsigned integer" format.

The block data is read using the calls:

ViStatus _VI_FUNC chr52956_SequenceReadBlockData (ViSession vi, ViUInt16 count, chr52956SequenceData *sequenceData, ViUInt16 format);

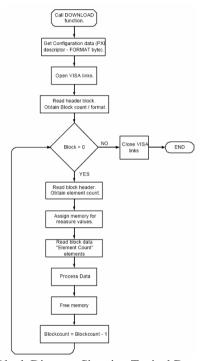


Figure 5-11 Block Diagram Showing Typical Download Steps

5.4.5 Types of Sequence

Although the sequence scans through a single table containing blocks of data on a module, it is possible to use the sequence to perform specific functions.

5.4.5.1 Single Sweep

This is used where a module or modules each run through a single sequence of outputting to function. This is the simplest way to use the modules.

5.4.5.2 Raster Scan

Used primarily for driving tunable laser diodes, each current source pattern is driven inside of another current source pattern, effectively forming a nested loop.

For example the inner loop might be stepped through a sequence of 10 currents, whereby the next inner loop would be indexed, and once again another 10 currents would be performed.

MODULE1			
BLOCK1	ELEMENT	DATA	
	1	1.005	
	2	1.010	
	3	1.015	
	4	1.020	
	5	1.025	
	6	1.030	
	7	1.035	
	8	1.040	
	9	1.045	
	10	1.050	
BLOCK2	ELEMENT	DATA	
	1	1.005	
	2	1.010	
	3	1.015	
	4	1.020	
	5	1.025	
	6	1.030	
	7	1.035	
	8	1.040	
	9	1.045	
	10	1.050	
BLOCK3	ELEMENT	DATA	
	1	1.005	
	2	1.010	
	3	1.015	
	4	1.020	
	5	1.025	
	6	1.030	
	7	1.035	
	8	1.040	
	9	1.045	
	10	1.050	

	MODINES	1
DI OCIZI	MODULE2	DATEA
BLOCK1	ELEMENT	DATA
	1	1.005
	2	1.005
	3	1.005
	4	1.005
	5	1.005
	6	1.005
	7	1.005
	8	1.005
	9	1.005
	10	1.005
BLOCK2	ELEMENT	DATA
	1	1.010
	2	1.010
	3	1.010
	4	1.010
	5	1.010
	6	1.010
	7	1.010
	8	1.010
	9	1.010
	10	1.010
BLOCK3	ELEMENT	DATA
	1	1.015
	2	1.015
	3	1.015
	4	1.015
	5	1.015
	6	1.015
	7	1.015
	8	1.015
	9	1.015
	10	1.015
C 10 D1	1 D /	C T 1

Table 5-2 Example Showing Three Blocks of a 10 Blocks Raster Scan Table

This type of sequence may require many delay blocks to be inserted after each loop, to allow the current to settle. This will depend on the application.

5.4.6 Data Formats on the Sequencer

The High Speed Instrument Sequencer (HSIS) is designed to be adaptable for use with various instrument configurations, and is suitable for using with a range of Chroma's instrument modules with HSIS functionality.

For each step of the sequencer, compatible PXI modules can perform one or two source operations, one or two measure operations, one source and one measure operation, or one or two NULL operations. The NULL is this case meaning perform no operation. NULL operations are provided for instances where users are using multiple PXI HSIS modules and a module or module channel may be required not to do anything while other modules are performing.

Before running a sequence, each module must have its mode of operation configured. This is achieved by setting bits in a control mode FORMAT byte. Each bit represents a mode of operation and if set, the module will perform the mode of I/O operation if it is capable of it. The FORMAT byte is the fourth byte of the sequence table.

Although the FORMAT byte has 6 settable bits, only the first three bits are used with Chroma 52956 modules. Only a maximum of two bits should be set at any time. The other bits should be set to zero.

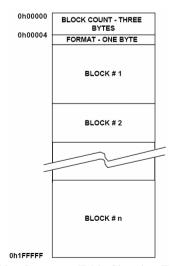


Figure 5-12 Sequence Table Showing Format Byte

Each bit set will reserve two bytes memory allocation for each sequence step. Each module in the same sequence group with HSIS functionality must use the same number of bytes as the sequence tables loaded into each module must be identical in element positioning. If there is a mismatch between modules of the same group, the sequence will not run correctly and cause un-expected results or an exception error.

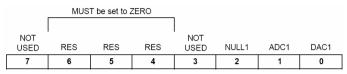


Figure 5-13 FORMAT Byte

Example:

An application requires one Chroma 52956 Current Source/Measure Module to supply current. No measurements are required. A second PXI module is connected which has two types of function. Therefore, although Chroma 52956 does not require four bytes in each element, it must use four bytes so that its table matches the table structure in the other module. The binary word 00000101 or Hex 0x05 would be written to the FORMAT byte of the module's table.

NOT USED	RES	RES	RES	NOT USED	NULL1	ADC1	DAC1
0	0	0	0	0	1	0	1
7	6	5	4	3	2	1	0

Figure 5-14 FORMAT Byte Used in above Example

6. DLL Calls and Example

Programs

6.1 DLL Calls

6.1.1 chr52956_init

ViStatus chr52956_init (ViRsrc resourceName, ViBoolean IDQuery, ViBoolean resetDevice, ViPSession instrumentHandle);

Purpose

This function performs the following initialization actions:

- Creates a new IVI instrument driver session.
- Opens a session to the specified device using the interface and address you specify for the Resource Name parameter.
- If the ID Query parameter is set to VI_TRUE, this function queries the instrument ID and checks that it is valid for this instrument driver.
- If the Reset parameter is set to VI_TRUE, this function resets the instrument to a known state.
- Sends initialization commands to set the instrument to the state necessary for the operation of the instrument driver.
- Returns a ViSession handle that you use to identify the instrument in all subsequent instrument driver function calls.

Note: This function creates a new session each time you invoke it.

Although you can open more than one IVI session for the same resource, it is best not to do so. You can use the same session in multiple program threads. You can use the chr52956_LockSession and chr52956_UnlockSession functions to protect sections of code that require exclusive access to the resource.

Parameter List

resourceName

Variable Type ViRsrc

Pass the resource name of the device to initialize.

You can also pass the name of a virtual instrument or logical name that you configure with the IVI Configuration utility. The virtual instrument identifies a specific device and specifies the initial settings for the session. A logical Name identifies a particular virtual instrument.

IDOuerv

Variable Type ViBoolean

Specify whether you want the instrument driver to perform Cn ID Query.

Valid Range:

VI_TRUE (1) - Perform ID Query (Default Value)

VI_FALSE (0) - Skip ID Query

resetDevice

Variable Type ViBoolean

Specify whether you want to reset the instrument during the initialization procedure.

Valid Range:

VI_TRUE (1) - Reset Device (Default Value)

VI FALSE (0) - Don't Reset

instrumentHandle

Variable Type ViSession (passed by reference)

Returns a ViSession handle that you use to identify the instrument in all subsequent instrument driver function calls.

Notes:

- This function creates a new session each time you invoke it. This is useful if you have multiple physical instances of the same type of instrument.
- (2) Avoid creating multiple concurrent sessions to the same physical instrument. Although you can create more than one IVI session for the same resource, it is best not to do so. A better approach is to use the same IVI session in multiple execution threads. You can use functions chr52956_LockSession and chr52956_UnlockSession to protect sections of code that require exclusive access to the resource.

Return Value

6.1.2 chr52956_InitWithOptions

ViStatus chr52956_InitWithOptions (ViRsrc resourceName,

ViBoolean IDQuery, ViBoolean resetDevice, ViString optionString, ViPSession instrumentHandle);

Purpose

This function performs the following initialization actions:

- Creates a new IVI instrument driver and optionally sets the initial state of the following session attributes:

CHR52956_ATTR_RANGE_CHECK CHR52956_ATTR_QUERY_INSTR_STATUS CHR52956_ATTR_CACHE CHR52956_ATTR_SIMULATE CHR52956_ATTR_RECORD_COERCIONS

- Opens a session to the specified device using the interface and address you specify for the Resource Name parameter.
- If the ID Query parameter set to VI_TRUE, this function queries the instrument ID and checks that it is valid for this instrument driver.
- If the Reset parameter set to VI_TRUE, this function resets the instrument to a known state.
- Sends initialization commands to set the instrument to the state necessary for the operation of the instrument driver.
- Returns a ViSession handle that you use to identify the instrument in all subsequent instrument driver function calls.

Note: This function creates a new session each time you invoke it.

Although you can open more than one IVI session for the same resource, it is best not to do so. You can use the same session in multiple program threads. You can use the chr52956_LockSession and chr52956_UnlockSession functions to protect sections of code that require exclusive access to the resource.

Parameter List

resourceName

Variable Type ViRsrc

Pass the resource name of the device to initialize.

You can also pass the name of a virtual instrument or logical name that you configure with the IVI Configuration utility. The virtual instrument identifies a specific device and specifies the initial settings for the session. A logical Name identifies a particular virtual instrument.

IDQuery

Variable Type ViBoolean

Specify whether you want the instrument driver to perform ID Query.

Valid Range:

VI_TRUE (1) - Perform ID Query (Default Value)

VI_FALSE (0) - Skip ID Query

resetDevice

Variable Type ViBoolean

Specify whether you want the to reset the instrument during the initialization procedure.

Valid Range:

VI_TRUE (1) - Reset Device (Default Value)

VI FALSE (0) - Don't Reset

optionString

Variable Type ViString

You can use this control to set the initial value of certain attributes for the session. The following table lists the attributes and the name you use in this parameter to identify the attribute.

Name	Attribute Defined Constant		
RangeCheck	CHR52956_ATTR_RANGE_CHECK		
QueryInstrStatus	CHR52956_ATTR_QUERY_INSTR_STATUS		
Cache	CHR52956_ATTR_CACHE		
Simulate	CHR52956_ATTR_SIMULATE		
RecordCoercions	CHR52956_ATTR_RECORD_COERCIONS		

The format of this string is, "AttributeName=Value" where AttributeName is the name of the attribute and Value is the value to which the attribute will be set. To set multiple attributes, separate their assignments with a comma.

If you pass NULL or an empty string for this parameter and a VISA resource descriptor for the Resource Name parameter, the session uses the default values for the attributes. The default values for the attributes are shown below:

Attribute Name	Default Value
RangeCheck	VI_TRUE
QueryInstrStatus	VI_TRUE
Cache	VI_TRUE
Simulate	VI_FALSE
RecordCoercions	VI_FALSE

You can override the values of the attributes by assigning a value explicitly in a string you pass for this parameter. You do not have to specify all of the attributes and may leave any of them out. If you do not specify one of the attributes, its default value or the value that you configure with the IVI Configuration utility will be used.

The following are the valid values for ViBoolean attributes:

True: 1, TRUE, or VI_TRUE False: 0, False, or VI_FALSE

Default Value:

instrumentHandle

Variable Type ViSession (passed by reference)

Returns a ViSession handle that you use to identify the instrument in all subsequent instrument driver function calls.

Notes:

- This function creates a new session each time you invoke it. This is useful if you have multiple physical instances of the same type of instrument.
- (2) Avoid creating multiple concurrent sessions to the same physical instrument. Although you can create more than one IVI session for the same resource, it is best not to do so. A better approach is to use the same IVI session in multiple execution threads. You can use functions chr52956_LockSession and chr52956_UnlockSession to protect sections of code that require exclusive access to the resource.

Return Value

[&]quot;Simulate=0,RangeCheck=1,QueryInstrStatus=1,Cache=1"

6.1.3 chr52956_close

ViStatus chr52956 close (ViSession instrumentHandle);

Purpose

This function performs the following operations:

- Closes the instrument I/O session.
- Destroys the instrument driver session and all of its attributes.
- Deallocates any memory resources the driver uses.

Notes:

- (1) You must unlock the session before calling chr52956_close.
- (2) After calling chr52956_close, you cannot use the instrument driver again until you call chr52956_init or chr52956_InitWithOptions.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.4 chr52956_SetComplianceVoltage

ViStatus chr52956_SetComplianceVoltage (ViSession instrumentHandle, ViReal64 voltage);

Purpose

This function sets the compliance voltage value in volts.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

voltage

Variable Type ViReal64 The voltage value in volts.

Unit: Volt

Valid Value: 0V to 8V.

Return Value

6.1.5 chr52956_SetCurrent

ViStatus chr52956_SetCurrent (ViSession instrumentHandle, ViReal64 current);

Purpose

This function sets the output current value of the module.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

current

Variable Type ViReal64

The output current of the module. According to different output range, the output current is range from 0mA to 500mA.

Unit: mA

Valid Value: 0 to 50mA (0 to 50mA current range) 0 to 500mA (0 to 500mA current range)

Return Value

6.1.6 chr52956_SetWireMode

ViStatus chr52956_SetWireMode (ViSession instrumentHandle, ViUInt16 wireMode);

Purpose

This function determines whether the voltage reading is internal (2 wire), or external (4 wire). 2 wire is used for measuring the source voltage on the current output. 4 wire is used for measuring the actual voltage on the current source or another voltage source.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

wireMode

Variable Type ViUInt16

The wire mode is to set the instrument.

Valid Value : 2-wire (0) CHR52956_VAL_2W - Default value 4-wire (1) CHR52956_VAL_4W

Return Value

6.1.7 chr52956_SetOutputRange

ViStatus chr52956_SetOutputRange (ViSession instrumentHandle, ViUInt16 range);

Purpose

This function configures the current output range. By default a 0 to 500mA range is provided. However a 0 to 50mA range can be selected giving finer current resolution.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

range

Variable Type ViUInt16

The current output range.

Valid Value : (0) CHR52956_VAL_500mA - Default value

(1) CHR52956_VAL_50mA

Return Value

6.1.8 chr52956_ConnectOutput

ViStatus chr52956_ConnectOutput (ViSession instrumentHandle);

Purpose

This function enables the output relay to make the current source module start to generate output. It will let current be zero. Then connect output relay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.9 chr52956_DisonnectOutput

ViStatus chr52956_DisonnectOutput (ViSession instrumentHandle);

Purpose

This function disables the output relay preventing the current source module from driving current. It will let current be zero. Then disconnect output relay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.10 chr52956_SetMeasureAverage

ViStatus chr52956_SetMeasureAverage (ViSession instrumentHandle, ViUInt16 measureAverage);

Purpose

This function sets the measure average.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

measureAverage

Variable Type ViUInt16

The measure average. It should be power of 2.

Valid Value: 0, 1, 2, 4, 8, 16, 32, 64, 128

Return Value

6.1.11 chr52956_SetTriggerSetup

ViStatus chr52956_SetTriggerSetup (ViSession instrumentHandle, ViUInt16 trigger);

Purpose

This function enables the specific trigger bus channel(s) which the sequencing engine can use.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

trigger

Variable Type ViUInt16

The trigger to be set.

Valid Value: (0x00) CHR52956_VAL_TRIG_NONE (0x01) CHR52956_VAL_TRIG0_IN (0x02) CHR52956_VAL_TRIG1_IN (0x04) CHR52956_VAL_TRIG2_IN (0x08) CHR52956_VAL_TRIG7_IN (0x10) CHR52956_VAL_TRIG0_OUT (0x20) CHR52956_VAL_TRIG1_OUT (0x40) CHR52956_VAL_TRIG1_OUT

(0x80) CHR52956 VAL TRIG7 OUT

Return Value

6.1.12 chr52956_SetMasterMode

ViStatus chr52956_SetMasterMode (ViSession instrumentHandle, ViUInt16 mode):

Purpose

This function enables the sequencing engine to drive I_SYNC rather than receive it, and therefore control other slave boards.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

mode

Variable Type ViUInt16

The mode of the instrument. The Master mode means the instrument is capable to generate I_SYNC while the Slave mode means the instrument is capable to receive I_SYNC.

Valid Value: (0) CHR52956_VAL_SLAVE - Default value (1) CHR52956 VAL MASTER

Return Value

6.1.13 chr52956_SetLocalRelay

ViStatus chr52956_SetLocalRelay (ViSession instrumentHandle, ViUInt16 relay);

Purpose

This function controls the local relays used to connect the adjacent left and right modules. Both S_RDY and M_RDY are connected.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

relay

Variable Type ViUInt16

The relay is connected or disconnected.

Valid Value: (0) Both relay OFF - Default value

- (1) CHR52956_VAL_LEFT_RELAY
- (2) CHR52956_VAL_RIGHT_RELAY
- (3) Both relay ON

Return Value

6.1.14 chr52956_SetHWTriggerMode

ViStatus chr52956_SetHWTriggerMode (ViSession instrumentHandle, ViBoolean enabled);

Purpose

This function allows the sequencing engine to use external triggers such as the I/O stage ready signals, and external user triggers. It also allows the hardware stabilization duration to be set, which controls when the H/W trigger is used by the sequencing engine.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

enabled

Variable Type ViBoolean Enable hardware trigger or not.

Valid Value : VI_TRUE Enabled VI FALSE Disabled

Return Value

6.1.15 chr52956_SetMaximumCurrent

ViStatus chr52956_SetMaximumCurrent (ViSession instrumentHandle, ViReal32 maxCurrent):

Purpose

This function sets the maximum current of the instrument. The maximum current is used to limit the maximum current value that user can set.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

maxCurrent

Variable Type ViReal32
The maximum current value to be set.

Unit: mA

Valid Value: 0 to 50mA (0 to 50mA output range) 0 to 500mA (0 to 500mA output range)

Return Value

6.1.16 chr52956_ReadMaximumCurrent

ViStatus chr52956_ReadMaximumCurrent (ViSession instrumentHandle, ViPReal32 value):

Purpose

This function reads the maximum current from the instrument. The maximum current is used to limit the maximum current value that user can set.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session

value

Variable Type ViReal32 (passed by reference)
The maximum current value read from the instrument.

Unit: mA

Return Value

6.1.17 chr52956_GetRelayThresholds

ViStatus chr52956_GetRelayThresholds (ViSession instrumentHandle,

ViPUInt32 relayONOFFThreshold,

ViPUInt32

wireModeRelayThreshold,

ViPUInt32 rangeRelayThreshold, ViPUInt32 localLeftRelayThreshold, ViPUInt32

localRightRelayThreshold);

Purpose

This function reads the threshold value of relay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

relayONOFFThreshold

Variable Type ViUInt32 (passed by reference)

The threshold value of ON/OFF relay.

wireModeRelayThreshold

Variable Type ViUInt32 (passed by reference)

The threshold value of wire mode relay.

rangeRelayThreshold

Variable Type ViUInt32 (passed by reference)

The threshold value of range relay.

local Left Relay Threshold

Variable Type ViUInt32 (passed by reference)

The threshold value of local left relay.

localRightRelayThreshold

Variable Type ViUInt32 (passed by reference)

The threshold value of local right relay.

Return Value

6.1.18 chr52956_SetRelayThresholds

ViStatus chr52956_SetRelayThresholds (ViSession instrumentHandle,

ViUInt32 relayONOFFThreshold, ViUInt32 wireModeRelayThreshold, ViUInt32 rangeRelayThreshold, ViUInt32 localLeftRelayThreshold, ViUInt32

localRightRelayThreshold);

Purpose

This function sets the threshold value of relay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

relayONOFFThreshold

Variable Type ViUInt32 The threshold value of ON/OFF relay.

wire Mode Relay Threshold

Variable Type ViUInt32

The threshold value of wire mode relay.

range Relay Threshold

Variable Type ViUInt32 The threshold value of range relay.

localLeftRelayThreshold

Variable Type ViUInt32

The threshold value of local left relay.

localRightRelayThreshold

Variable Type ViUInt32

The threshold value of local right relay.

Return Value

6.1.19 chr52956_UpdateRelayInfoToEEPROM

ViStatus chr52956_UpdateRelayInfoToEEPROM (ViSession instrumentHandle, ViPUInt16 relayStatus);

Purpose

This function writes the relay information to EEPROM.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

relayStatus

Variable Type ViUInt16 (passed by reference)

The status of relay. It indicates which relay is over the relay count

threshold.

bit 0 : ON/OF Relay bit 1 : Wire Mode Relay bit 2 : Range Relay bit 3 : Local Left Relay bit 4 : Local Right Relay

Return Value

6.1.20 chr52956_ReadVoltage

ViStatus chr52956_ReadVoltage (ViSession instrumentHandle, ViPReal64 measurement);

Purpose

This function reads the measured voltage. The source of the voltage is either internal or external.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

measurement

Variable Type ViReal64 (passed by reference) Returns the measured value.

Units: volts

Return Value

6.1.21 chr52956_SequenceRunMaster

ViStatus chr52956_SequenceRunMaster (ViSession instrumentHandle);

Purpose

This function makes the instrument to run master mode in a sequence group.

Note: Before call this function, you must call chr52956_SequenceReset first

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.22 chr52956_SequenceRunSlave

ViStatus chr52956_SequenceRunSlave (ViSession instrumentHandle);

Purpose

This function makes the instrument to run slave mode in a sequence group.

Note: Before calling this function, you must call chr52956_SequenceReset first.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.23 chr52956_SequenceReset

ViStatus chr52956_SequenceReset (ViSession instrumentHandle);

Purpose

This function resets the sequence pointer in the instrument.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.24 chr52956_SequenceWriteHeaderBlock

ViStatus chr52956_SequenceWriteHeaderBlock (ViSession instrumentHandle, ViUInt32 block_count, ViUInt16 format):

Purpose

This function configures the header of the sequence table.

Note: Before calling this function, you must call chr52956_SequenceReset first.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

block count

Variable Type ViUInt32

The block counts in the sequence table.

format

Variable Type ViUInt16
The format of the sequence table.

Valid Value: (1) - Source Only

(2) - Measure Only

(3) - Source and Measure

Return Value

6.1.25 chr52956_SequenceReadHeaderBlock

ViStatus chr52956_SequenceReadHeaderBlock (ViSession instrumentHandle, ViPUInt32 block_count, ViPUInt16 format):

Purpose

This function reads the maximum current from instrument. The maximum current is used to limit the maximum current value that user can set.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

block count

Variable Type ViUInt32 (passed by reference)

The block counts in the sequence table.

format

Variable Type ViUInt16 (passed by reference)

The format of the sequence table.

Valid Value: (1) - Source Only

- (2) Measure Only
- (3) Source and Measure

Return Value

6.1.26 chr52956_SequenceWriteBlockHeader

ViStatus chr52956_SequenceWriteBlockHeader (ViSession instrumentHandle,

ViUInt16 count, ViUInt16 sourceDelay, ViUInt16 measureDelay);

Purpose

This function sets the header information of the block, including element count, source delay and measure delay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

count

Variable Type ViUInt16
The element count of the block.

sourceDelay

Variable Type ViUInt16 The source delay of this block.

measureDelay

Variable Type ViUInt16 The measure delay of this block.

Return Value

6.1.27 chr52956_SequenceReadBlockHeader

 $\label{lem:continuous} ViStatus~chr 52956_S equence Read Block Header~(ViSession~instrument Handle, ViPUInt 16~count,$

ViPUInt16 sourceDelay, ViPUInt16 measureDelay);

Purpose

This function reads the header information of the block, including element count, source delay and measure delay.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

count

Variable Type ViUInt16 (passed by reference)

The element count of the block.

sourceDelay

Variable Type ViUInt16 (passed by reference)

The source delay of this block.

measureDelay

Variable Type ViUInt16 (passed by reference)

The measure delay of this block.

Return Value

6.1.28 chr52956_SequenceWriteBlockData

ViStatus chr52956_SequenceWriteBlockData (ViSession instrumentHandle,

ViUInt16 count, chr52956SequenceData*sequenceData, ViUInt16 format);

Purpose

This function sets the block data of the sequence table.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

count

Variable Type ViUInt16
The element count of the block.

sequenceData

Variable Type chr52956SequenceData*
The pointer of sequencer data belongs to this block.

format

Variable Type ViUInt16 The format of the sequence table.

Valid Value: (1) - Source Only

(2) - Measure Only

(3) - Source and Measure

Return Value

6.1.29 chr52956_SequenceReadBlockData

ViStatus chr52956_SequenceReadBlockData (ViSession instrumentHandle, ViUInt16 count, chr52956SequenceData *sequenceData, ViUInt16 format);

Purpose

This function reads the block data of the sequence table.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session

count

Variable Type ViUInt16
The element count of the block.

sequenceData

Variable Type chr52956SequenceData (passed by reference) The pointer of sequencer data belongs to this block.

format

Variable Type ViUInt16 The format of the sequence table.

Valid Value: (1) - Source Only

(2) - Measure Only

(3) - Source and Measure

Return Value

6.1.30 chr52956_SequenceWriteBlockDataArray

ViStatus chr52956_SequenceWriteBlockDataArray (ViSession instrumentHandle,

ViUInt16 count, ViReal64 *source, ViReal64 *measure, ViUInt16 format);

Purpose

This function sets the block data of the sequence table. The parameter uses array instead of structure. It is convenient for VB 6.0.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

count

Variable Type ViUInt16
The element count of the block.

source

Variable Type ViReal64 (passed by reference) The array of source data.

measure

Variable Type ViReal64 (passed by reference)

The array of measure data.

format

Variable Type ViUInt16
The format of the sequence table.

Valid Value: (1) - Source Only

(2) - Measure Only

(3) - Source and Measure

Return Value

6.1.31 chr52956_SequenceReadBlockDataArray

ViStatus chr52956_SequenceReadBlockDataArray (ViSession instrumentHandle,

ViUInt16 count, ViReal64 *source, ViReal64 *measure, ViUInt16 format);

Purpose

This function reads the block data of the sequence table. The parameter uses array instead of structure. It is convenient for VB 6.0.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

count

Variable Type ViUInt16
The element count of the block.

source

Variable Type ViReal64 (passed by reference)

The returned array of source data.

measure

Variable Type ViReal64 (passed by reference)

The returned array of measured data.

format

Variable Type ViUInt16 The format of the sequence table.

Valid Value: (1) - Source Only

(2) - Measure Only

(3) - Source and Measure

Return Value

6.1.32 chr52956_SetSequenceRunLoopMultiplier

ViStatus chr52956_SetSequenceRunLoopMultiplier (ViSession instrumentHandle, ViInt32 loopMultiplier);

Purpose

This function sets the loop delay count, for example if source delay is set to 100, (100 * 100 uS) = 10000 uS or 10 mS, a loop count of 20 will generate delays of 20 * 10 mS = 300 mS delays up to 256 * 255 * 100 uS are available = 6.528 seconds.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

loopMultiplier

Variable Type ViInt32

The sequence runs loop multiplier.

Return Value

6.1.33 chr52956_SequenceStatus

ViStatus chr52956_SequenceStatus (ViSession instrumentHandle, ViPUInt16 status);

Purpose

This function returns the status of the sequence engine. It indicates if the sequence engine is completed and if there is an error occurred.

Note: This function is valid only after sequence is started.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

status

Variable Type ViUInt16 (passed by reference) Indicates the status of the sequencer engine.

Possible value:

- 0 running
- 1 sequence error
- 2 sequence done
- 3 sequence error and done

Return Value

6.1.34 chr52956_reset

ViStatus chr52956_reset (ViSession instrumentHandle);

Purpose

This function resets the instrument to a known state and sends initialization commands to the instrument. This function also clears the sequencer table in the instrument. The initialization commands set instrument settings such as Headers Off, Short Command form, and Data Transfer Binary to the state necessary for the operation of the instrument driver.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session.

Return Value

6.1.35 chr52956_error_message

ViStatus chr52956_error_message (ViSession instrumentHandle, ViStatus errorCode, ViChar _VI_FAR errorMessage[]);

Purpose

This function converts a status code returned by an instrument driver function into a user-readable string.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session. You can pass VI_NULL for this parameter. This is useful when one of the initialize functions fail.

errorCode

Variable Type ViStatus

Pass the Status parameter that is returned from any of the instrument driver functions.

errorMessage

Variable Type ViChar[]

Returns the user-readable message string that corresponds to the status code you specify. You must pass a ViChar array with at least 256 bytes.

Return Value

6.1.36 chr52956_ReadRangeLimit

ViStatus chr52956_ReadRangeLimit (ViSession instrumentHandle, ViPReal32 HighRange, ViPReal32 LowRange);

Purpose

Using this function to get the current range value of the device.

Parameter List

instrumentHandle

Variable Type ViSession

The ViSession handle that you obtain from the chr52956_init or chr52956_InitWithOptions function. The handle identifies a particular instrument session. You can pass VI_NULL for this parameter. This is useful when one of the initialize functions fail.

HighRange

Variable Type ViReal32 (passed by reference) Return the high current range value of the device.

LowRange

Variable Type ViReal32 (passed by reference) Return the low current range value of the device.

Return Value

6.1.37 Other Driver Functions

Please refer the file of chr52956.HLP for detail description of each driver function.

6.2 Error Code

52956 Status Codes:

ERRORS:

BFFA4001 The Sequence engine is currently running.

BFFA4002 Can't change the wire mode when the output is enabled.

BFFA4062 Read packet error.

BFFA4063 Write packet error.

IviPower Status Codes:

BFFA0001 Instrument error.

BFFA0002 Cannot open file.

BFFA0003 Error reading from file.

BFFA0004 Error writing to file.

BFFA0005 Driver module file not found.

BFFA0006 Cannot open driver module file for reading.

BFFA0007 Driver module has invalid file format or invalid data.

BFFA0008 Driver module contains undefined references.

BFFA0009 Cannot find function in driver module.

BFFA000A Failure loading driver module.

BFFA000B Invalid path name.

BFFA000C Invalid attribute.

BFFA000D IVI attribute is unable to write.

BFFA000E IVI attribute is not readable.

BFFA000F Invalid parameter.

BFFA0010 Invalid value.

BFFA0011 Function not supported.

BFFA0012 Attribute not supported.

BFFA0013 Value not supported.

BFFA0014 Invalid type.

BFFA0015 Types do not match.

BFFA0016 Attribute already has a value waiting to be updated.

BFFA0017 Specified item already exists.

BFFA0018 Not a valid configuration.

BFFA0019 Requested item does not exist or value not available.

BFFA001A Requested attribute value not known.

BFFA001B No range table.

BFFA001C Range table is invalid.

BFFA001D Object or item is not initialized.

BFFA001E Non-interchangeable behavior.

```
BFFA001F
            No channel table has been built for the session.
BFFA0020
            Channel name specified is not valid.
BFFA0021
            Unable to allocate system resource.
BFFA0022
            Permission to access file was denied.
BFFA0023
            Too many files are already opened.
            Unable to create temporary file in target directory.
BFFA0024
BFFA0025
            All temporary filenames are already used.
BFFA0026
            Disk is full.
            Cannot find configuration file on disk.
BFFA0027
BFFA0028
            Cannot open configuration file.
            Error reading configuration file.
BFFA0029
            Invalid ViInt32 value in configuration file.
BFFA002A
BFFA002B
            Invalid ViReal64 value in configuration file.
BFFA002C
            Invalid ViBoolean value in configuration file.
            Entry missing from configuration file.
BFFA002D
            Initialization failed in driver DLL.
BFFA002E
BFFA002F
            Driver module has unresolved external reference.
BFFA0030
            Cannot find CVI Run-Time Engine.
BFFA0031
            Cannot open CVI Run-Time Engine.
BFFA0032
            CVI Run-Time Engine has invalid format.
BFFA0033
            CVI Run-Time Engine is missing required function(s).
BFFA0034
            CVI Run-Time Engine initialization failed.
            CVI Run-Time Engine has unresolved external reference.
BFFA0035
            Failure loading CVI Run-Time Engine.
BFFA0036
            Cannot open DLL for read exports.
BFFA0037
            DLL file is corrupt.
BFFA0038
            No DLL export table in DLL.
BFFA0039
BFFA003A
            Unknown attribute name in default configuration file.
            Unknown attribute value in default configuration file.
BFFA003B
BFFA003C
            Memory pointer specified is not known.
BFFA003D
            Unable to find any channel strings.
BFFA003E
            Duplicate channel string.
BFFA003F
            Duplicate virtual channel name.
BFFA0040
            Missing virtual channel name.
            Bad virtual channel name.
BFFA0041
            Unassigned virtual channel name.
BFFA0042
            Bad virtual channel assignment.
BFFA0043
            Channel name required.
BFFA0044
BFFA0045
            Channel name not allowed.
BFFA0046
            Attribute not valid for channel.
```

Attribute must be channel based.

Channel already excluded.

BFFA0047

BFFA0048

Missing option name (nothing before the '='). BFFA0049 BFFA004A Missing option value (nothing after the '='). BFFA004B Bad option name. BFFA004C Bad option value. Operation only valid on a class driver session. BFFA004D "ivi.ini" filename is reserved. BFFA004E BFFA004F Duplicate run-time configuration entry. BFFA0050 Index parameter is one-based. BFFA0051 Index parameter is too high. BFFA0052 Attribute is not cacheable. You cannot export a ViAddr attribute to the end-user. BFFA0053 BFFA0054 Bad channel string in channel string list. BFFA0055 Bad prefix name in default configuration file. VISA Status Codes: WARNINGS: 3FFF0002 Event enabled for one or more specified mechanisms. 3FFF0003 Event disabled for one or more specified mechanisms. 3FFF0004 Successful, but queue already empty. 3FFF0005 Specified termination character was read. 3FFF0006 Number of bytes transferred equals input count. 3FFF0077 Configuration non-existent or could not be loaded. Open successful, but the device not responding. 3FFF007D Wait successful, but more event objects available. 3FFF0080 Specified object reference is not initialized. 3FFF0082 3FFF0084 Attribute value not supported. 3FFF0085 Status code could not be interpreted. 3FFF0088 Specified I/O buffer type not supported. Successful, but invoke no handler for this event. 3FFF0098 3FFF0099 Successful but session has nested shared locks.

ERRORS:

3FFF009A

3FFF009B

BFFF0000	Unknown system error (miscellaneous error).		
BFFF000E	Session or object reference is invalid.		
BFFF000F	Resource is locked.		
BFFF0010	Invalid expression specified for search.		
BFFF0011	Resource is not presented in the system.		
BFFF0012	Invalid resource reference specified. Parsing error.		
BFFF0013	Invalid access mode.		
BFFF0015	Timeout expired before operation completed.		

Successful but session has nested exclusive locks.

Successful but operation not asynchronous.

BFFF0016

Unable to deallocate session data structures.

```
BFFF001B
            Specified degree is invalid.
            Specified job identifier is invalid.
BFFF001C
BFFF001D
            Attribute does not support by the referenced object.
BFFF001E
            Attribute state does not support by the referenced object.
            Specified attribute is read-only.
BFFF001F
            Lock type not supported by this resource.
BFFF0020
BFFF0021
            Invalid access key.
            Specified event type not supported by the resource.
BFFF0026
            Invalid mechanism specified.
BFFF0027
BFFF0028
             A handler was not installed.
            Handler reference either invalid or was not installed.
BFFF0029
BFFF002A
            Specified event context invalid.
            Event queue for specified type has overflowed.
BFFF002D
            Event type must be enabled in order to receive.
BFFF002F
BFFF0030
             User aborts during transfer.
BFFF0034
            Violation of raw write protocol during transfer.
            Violation of raw read protocol during transfer.
BFFF0035
            Device reported output protocol error during transfer.
BFFF0036
BFFF0037
            Device reported input protocol error during transfer.
            Bus error during transfer.
BFFF0038
            Unable to queue asynchronous operation.
BFFF0039
            Unable to start operation because setup is invalid.
BFFF003A
            Unable to queue the asynchronous operation.
BFFF003B
            Insufficient resources to perform memory allocation.
BFFF003C
            Invalid buffer mask specified.
BFFF003D
BFFF003E
            I/O error.
            Format specifier invalid.
BFFF003F
             Format specifier not supported.
BFFF0041
            Trigger line is currently in use.
BFFF0042
            Service request not received for the session.
BFFF004A
BFFF004E
            Invalid address space specified.
BFFF0051
            Invalid offset specified.
BFFF0052
            Invalid access width specified.
            Offset not accessible from this hardware.
BFFF0054
            Source and destination widths are different.
BFFF0055
            Session not currently mapped.
BFFF0057
             Previous response still pending.
BFFF0059
BFFF005F
            No listener condition detected.
BFFF0060
            Interface not currently the controller in charge.
            Interface is not the system controller.
BFFF0061
BFFF0067
            Session does not support this operation.
```

BFFF006A	A parity error occurred during transfer.
BFFF006B	A framing error occurred during transfer.
BFFF006C	An overrun error occurred during transfer.
BFFF0070	Offset not properly aligned for operation access width.
BFFF0071	Specified user buffer not valid.
BFFF0072	Resource valid, but VISA cannot access it.
BFFF0076	Width does not support by this hardware.
BFFF0078	Invalid parameter value, parameter unknown.
BFFF0079	Invalid protocol.
BFFF007B	Invalid window size.
BFFF0080	Session currently contains a mapped window.
BFFF0081	Operation is not implemented.
BFFF0083	Invalid length.
BFFF0091	Invalid mode.
BFFF009C	Session did not have a lock on the resource.
BFFF009D	The device does not export any memory.
BFFF009E	VISA-required code library not located or not loaded.

VXIPnP Driver Status Codes:

WA	$\mathbf{D} \mathbf{N} \mathbf{H}$		С.
VV A	RIVI	IVIT	· .

3FFC0101	Instrument does not have ID Query conchility
SEECOIOI	Instrument does not have ID Query capability.
3FFC0102	Instrument does not have Reset capability.
3FFC0103	Instrument does not have Self-Test capability.
3FFC0104	Instrument does not have Error Query capability.
3FFC0105	Instrument does not have Revision Query capability.

ERRORS:

BFFC0001	Parameter 1 out of range, or error trying to set it.
BFFC0002	Parameter 2 out of range, or error trying to set it.
BFFC0003	Parameter 3 out of range, or error trying to set it.
BFFC0004	Parameter 4 out of range, or error trying to set it.
BFFC0005	Parameter 5 out of range, or error trying to set it.
BFFC0006	Parameter 6 out of range, or error trying to set it.
BFFC0007	Parameter 7 out of range, or error trying to set it.
BFFC0008	Parameter 8 out of range, or error trying to set it.
BFFC0011	Instrument failed the ID Query.
BFFC0012	Invalid response from instrument.

6.3 Example Program

Following is an example of a test program written in C. This sample program shows how to write a sequence table and read voltage data after sequence engine is done successfully.

```
#include <userint.h>
#include <utility.h>
#include <ansi c.h>
#include "chr52956.h"
void main()
     ViSession chr52956;
    ViStatus error = VI_SUCCESS;
     ViUInt32 blockCount = 0;
    ViUInt16 format = 0;
    ViUInt16 elementCount = 0, controlWord = 0;
    ViUInt16 sourceDelay = 100, measureDelay = 100;
     chr52956SequenceDatadata;
    ViUInt32 blockCounter, elementCounter;
    ViReal64 current[10] = {11, 12, 13, 14, 15, 0};
     ViBoolean bStatus = VI_FALSE;
      /*
          If you want to run this sample program and the instrument
is
          not present, set the Simulate flag to 1. (Example:
"Simulate
          = 1")
      * /
     checkErr(chr52956_InitWithOptions("PXI1::14::INSTR", VI_TRUE,
        VI TRUE, "Simulate=0, RangeCheck=1,
        QueryInstrStatus=1, Cache=1", &chr52956));
     chr52956_SetMaximumCurrent (chr52956, 50);
     //Write Sequence Data
     //Sequence Reset
     checkErr(chr52956_SequenceReset(chr52956));
     //Write Sequence Data
     format = 3;
     data.source1.f = current;
     data.source2.f = 0;
     data.measure1.f = 0;
     data.measure2.f = 0;
     //Reset addres counter
     checkErr(chr52956_SequenceReset(chr52956));
```

```
//Write sequence header
     checkErr(chr52956 SequenceWriteHeaderBlock(chr52956, 1,
          format.)):
     //Write header of Block 1
     checkErr(chr52956_SequenceWriteBlockHeader(chr52956, 6,
          sourceDelay, measureDelay));
     checkErr(chr52956_SequenceWriteBlockData(chr52956, 6,
          &data, format));
     //Connect the output
     checkErr(chr52956_ConnectOutput(chr52956));
     //Set initial current and compliance voltage
     checkErr(chr52956_SetCurrent(chr52956, 10));
     checkErr(chr52956 SetComplianceVoltage(chr52956, 2));
     //Reset addres counter
     checkErr(chr52956_SequenceReset(chr52956));
     //Run master
     checkErr(chr52956_SequenceRunMaster(chr52956));
     //Wait for sequence to completion
     Delav(1);
     //Check sequence engine status
     checkErr(chr52956_SequenceStatus(chr52956, &bStatus));
     if (bStatus != 0x02) {
          MessagePopup("Warning", "Sequence engine occurred
error!");
          goto Error;
     //Read Sequence Data
     //Reset address count
     checkErr(chr52956 SequenceReset(chr52956));
     checkErr(chr52956 SequenceReadHeaderBlock(chr52956,
          &blockCount, &format));
     printf("Block count = %d, Format = 0x%X\n", blockCount, format);
     for (blockCounter=0; blockCounter<blockCount; blockCounter++) {</pre>
          printf("Block [%d]\n", blockCounter);
          data.source1.f = 0:
          data.measure1.f = 0;
          data.source2.f = 0;
          data.measure2.f = 0;
          checkErr(chr52956_SequenceReadBlockHeader(chr52956,
               &elementCount, &sourceDelay, &measureDelay));
          printf("elementCount = %d\n", elementCount);
```

```
printf("sourcedelay = %d\n", sourceDelay);
          printf("measuredelay = %d\n", measureDelay);
          //Allocate memory
          if (format & 0x01) {
               data.source1.f =
                   (ViReal64*) malloc(sizeof(ViReal64) *
elementCount);
          if (format & 0x02) {
               data.measure1.f =
                  (ViReal64*) malloc(sizeof(ViReal64) *
elementCount):
          }
          checkErr(chr52956 SequenceReadBlockData(chr52956,
               elementCount, &data, format));
          for (elementCounter=0; elementCounter<elementCount;
               elementCounter++) {
               if (format & 0x01) {
                    printf("source1[%d] = %f\n", elementCounter,
                        data.source1.f[elementCounter]);
               if (format & 0x02) {
                    printf("measure1[%d] = %f\n", elementCounter,
                        data.measure1.f[elementCounter]);
          //Release memory
          if (data.source1.f != NULL)
               free (data.source1.f);
          if (data.measure1.f != NULL)
               free (data.measure1.f);
     }
     //Disconnect output
     checkErr(chr52956 DisconnectOutput(chr52956));
     //Reset
     checkErr(chr52956_reset(chr52956));
Error:
   if (error != VI_SUCCESS)
          ViChar errStr[2048];
          chr52956_error_message (chr52956, error, errStr);
         MessagePopup ("Error!", errStr);
      }
   if (chr52956)
      chr52956_close (chr52956);
```

This sample program shows how to force current without sequence table.

```
#include <userint.h>
#include <utilitv.h>
#include <ansi c.h>
#include "chr52956.h"
void main()
    ViSession chr52956;
    ViStatus error = VI SUCCESS;
    ViUInt32 blockCount = 0;
     ViUInt16 format = 0;
     ViUInt16 elementCount = 0, controlWord = 0;
    ViUInt16 sourceDelay = 100, measureDelay = 100;
     chr52956SequenceDatadata:
     ViUInt32 blockCounter, elementCounter;
    ViReal64 current[10] = {11, 12, 13, 14, 15, 0};
    ViBoolean bStatus = VI_FALSE;
    ViReal32 hi, lo;
     //status = chr52956 InitWithOptions("PXI1::14::INSTR", VI TRUE,
VI TRUE, "Simulate=0", &vi);
          If you want to run this sample program and the instrument
is not
          present, set the Simulate flag to 1. (Example: "Simulate
= 1")
      */
     checkErr(chr52956_InitWithOptions("PXI2::13::INSTR", VI_TRUE,
     VI TRUE, "Simulate=0, RangeCheck=1, OueryInstrStatus=1, Cache=1",
     &chr52956));
     checkErr(chr52956_SetOutputRange(chr52956,CHR52956_VAL_RANGE_
500mA));
     checkErr(chr52956_SetComplianceVoltage(chr52956, 2));
     //Connect the output
     checkErr(chr52956 ConnectOutput(chr52956));
     checkErr(chr52956_SetCurrent(chr52956, 50));
     // void or Measure.....
     checkErr(chr52956 SetCurrent(chr52956, 0));
     //Disconnect output
     checkErr(chr52956_DisconnectOutput(chr52956));
     //Reset
     checkErr(chr52956_reset(chr52956));
Error:
   if (error != VI_SUCCESS)
```

7. Hardware Overview

The Chroma 52956 Current Source/Measure Module is a complex instrument which allows test engineers to rapidly provide current stimuli values from a table and store resultant voltage measurements back into the table during a sequence process which is independent of the host controller of the PXI system. These data tables may be downloaded to the module in preparation for a sequence stimuli run, or uploaded from the module into other applications such as spreadsheets for data analysis.

7.1 Hardware Block Diagram

Figure 7-1 is the block diagram of Chroma 52956 Current Source/Measure Module.

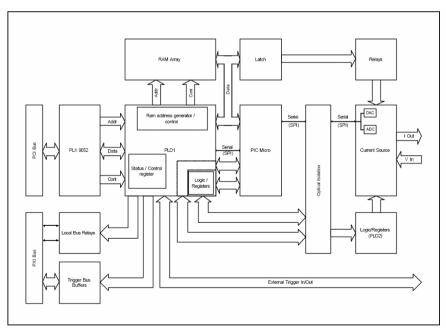


Figure 7-1 Hardware Architecture

7.2 Hardware

The current source is required to drive the constant current through the load. The following characteristics are required:

- The range of currents required is from 0mA to +500mA. It is possible to change the current output from one value to any other in the range without a glitch in the output voltage or current.
- The current source is driven by a 16-bit serial DAC.
- The voltage compliance is programmable over the range 0 to +8V. This will prevent the output voltage from exceeding the programmed limit.

The module can be divided into three main sections. These are the System Backplane Bus interface section (PXI and PCI), the sequence section and the analogue section.

7.2.1 Backplane Bus Section

The backplane bus connectors on the module (J1 and J2) provide connectivity the PCI system bus and the PXI bus segments. The PCI Bus interface handles the plug and play protocols for assigning the Chroma 52956 module to the backplane of the chassis. This PCI Bus interface is compliant to the PCI Bus Interface specification 2.1. It has a 32 bit interface for using with PXI/CompactPCI systems. It supports 8 bit local data bus bit transfers, local 4 bit address decoding and also has 4 local control lines (RD, WR, CS and RST) via a PLX9052 PCI interface I/C.

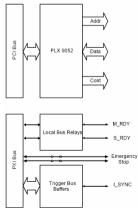


Figure 7-2 PCI and PXI Bus Connectivity

It supports both memory mapped burst accesses from the PCI bus to the local bus. The PCI interface contains a Serial EEPROM interface, which is used to load configuration information. This loads the information that is unique to Chroma 52956 such as model ID code and sub-ID code. The base address and range of each local address space are independently programmable from the Connectivity to the PXI bus is provided via the J2 connector on EEPROM. This allows connections via bus drivers to four of the eight the module. Trigger Bus lines. These are PXI TRIG0, PXI TRIG1, PXI TRIG2 and One of these four can be selected by the user for using with PXI TRIG7. their application.

Connections are also provided to the left and right local busses to connect each module to the module immediately adjacent to it. When more than one module is used in a group, the user can use relays and jumpers to connect the module to one or both of its local busses.

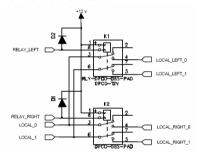


Figure 7-3 Local Bus Relay Circuit

Three of each of the local bus lines are used. These are PXI_LBL0 and PXI_LBR0 for the SRDY signal, PXI_LBL1 and PXI_LBR1 for the MRDY signal and PXI_LBL2 and PXI_LBR2 for the global emergency stop. The emergency stop loop is selected on the board by user selectable jumpers.

7.2.2 Sequence Engine Section

The sequence engine allows the current source to be stepped through a predefined sequence of settings. The board can be set either as a master or slave. The sequence engine is broken down into many subsections.

A memory array is provided to store the sequence of current settings and/or voltage measurements. This provides enough memory byte allocations to provide up to 500,000 32-bit sequence steps.

A PIC micro-controller is provided for sequence control. The PIC microcontroller is used to convert the block structure of the memory array into a format suitable for the output DAC and also take data from the Input ADC and convert it into the memory block structure. The PIC micro-controller is also used to time the programmed step time delays.

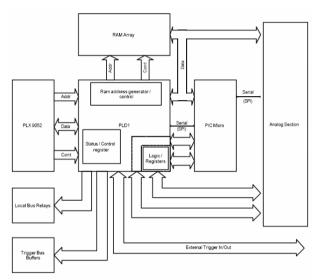


Figure 7-4 Block Diagram of Sequence Engine

A PLD (PLD1) is used to perform a number of functions. Its primary function is to control and run the Ram address generator. It controls the address index pointers auto increment, step increment and reset functions. It provides decoding between the PIC micro-controller and the local bus and also provides status registers and controls to monitor the status of the module, mode of operation (master / slave) and control the relays which are used to switch in the local busses and also provide control of the analogue section relays used for output, range, mode and calibration. An external trigger signal is provided to allow the sequence engine be stepped from an external source.

7.2.3 Analogue Section

The unit is capable of providing an accurate current stimulus output in the range of 0 to 500mA. The analogue section is isolated from the digital section by optical isolators to prevent spurious digital noise from affecting the stability of the output and to allow flexible external connections. Data is sent via a Serial Protocol Interface (SPI) port between the PIC micro-controller and the ADC and DAC circuits.

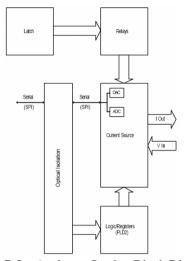


Figure 7-5 Analogue Section Block Diagram

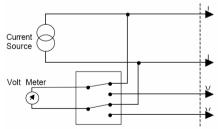


Figure 7-6 Current Source and Volt Meter Relay Switch

A second PLD provides logic decoding and status registers for the analogue section. Relays are used for output switching, range, mode and calibration. These are operated via a latched relay driver. The module is capable of measuring the voltage drop across its own current output as well as an independent voltage input.

7.3 High Speed Instrument Sequencer(HSIS) Overview

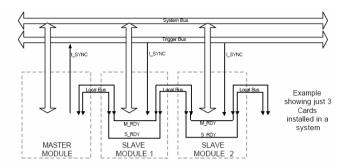
The purpose of the HI SPEED INSTRUMENT SEQUENCER is to provide hardware and software platform on which to build an Automatic Test System (ATS) which reduces test times in applications where a multitude of stimuli are required, followed by sampling of the data to provide a profile of the UUT (Unit Under Test).

7.3.1 Hardware Overview

Chroma 52956 Current Source/Measure Module incorporated the HI SPEED INSTRUMENT SEQUENCER (HSIS) functionality, can operate as a stand alone module or operate as part of a group of modules on a host system under a master/slave relationship with other modules which also have HSIS functionality. The master module will use one bit of the PXI Trigger Bus to provide a synchronization signal, known as I SYNC (Instrument Sync) which each slave module will use to coordinate activities with the master. module will provide connectivity to two bits of the PXI Local Bus, which will be used to inform the Master module of their state of readiness. One of these signals is called **S RDY** (Stimulus Ready) and is used to inform the master as to when the stimulus signal has stabilized. The second of these signals called M RDY (Measurement Ready) is used to inform the master when the data acquisition module is ready. Each module has the ability to electrically isolate itself from the Local Bus connected to the module immediately adjacent to A third PXI local bus signal is used to provide a daisy chained global emergency stop signal. This is connected with manually inserted hardware jumpers.

Signals from the Left Local Bus will be connected to the Right Local Bus when required using the modules with HSIS functionality when necessary. There may be more than one S_RDY and M_RDY signal driving onto the local bus. The driver IC's for these signals are open collector devices. Pull up resistors are provided on all modules which provide this functionality.

2 Mbytes of RAM is provided to store data tables for all of the stimulus and measurement data.



ONE MODULE ACTING AS A HI SPEED INSTRUMENT SEQUENCER MASTER WITH TWO HSIS SLAVE MODULES.

Figure 7-7 Example Multi Module Configuration

7.4 Trigger Bus Interface

Modules designed to implement the HSIS have hardware connectivity to the Trigger Bus. Although only one trigger bus line is used for the I_SYNC signal, each Master/Slave group, four Trigger Bus lines are connected via four trigger line buffers. This gives the user the option to select one out of four different trigger bus lines for his application. Signals PXI_TRIG0, PXI_TRIG1, PXI_TRIG2 and PXI_TRIG7 are used.

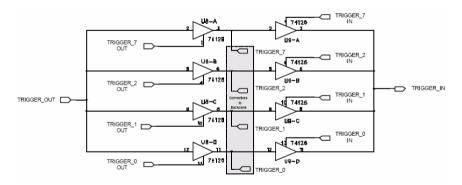


Figure 7-8 Trigger Line Bus Driver Circuit

7.5 Local Bus Interface

Two Local Bus Left and Local Bus Right signals are used to transport the S_RDY and M_RDY. Two mechanical relays are used to allow the user to connect or isolate the module from the module immediately adjacent to it on either side.

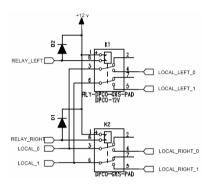


Figure 7-9 Local Bus Isolation / Connection Relays

Signals LBL0 (Local Bus Left) and LBL1 are used on the Local Bus Left and signals LBR0 (Local Bus Right) and LBR1 are used on the Local Bus Right. One is used for the S_RDY signal and the other is used for the M_RDY signal. S_RDY and M_RDY can be routed from an external source.

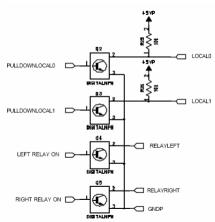


Figure 7-10 Open Collector Driver

More than one device may drive onto the local bus. Therefore open collector bus driver technology is used. Each used local Bus signal line has a 10K Ohm pull up resistor on it.

7.6 Synchronization

The Hi Speed Instrument Sequencer will operate under a Master / Slave relationship. One module will act as Master while all of the other modules in the system group using HSIS functionality will act as Slave devices. It is possible to have up to four Master / Slave groups on a system backplane Bus segment.

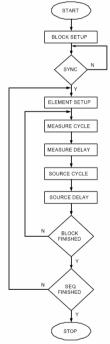


Figure 7-11 Flowchart of the Sequence Steps (Sequence Initialization and Sequence Running/Loop)

Initially, all modules must start up and be put into a known state. A start-up synchronization period occurs where all slave modules assert S_RDY and M RDY low followed by the master module assert M RDY and S RDY low.

The master module then asserts I_SYNC low followed by I_SYNC high. All modules will then de-assert their S_RDY and M_RDY.

The master waits until both S_RDY and M_RDY are high. The sequence now commences with the master detecting M_RDY high whereby I_SYNC is set low and an initial dummy measure cycle is performed. At the completion of this dummy measure cycle, a full stimulus/measure operation can occur.

7.6.1 Stimulus & Measurement

Slave modules will assert S_RDY and M_RDY low until I_SYNC is detected high. The sequence will begin on the next rising edge of I_SYNC.

The HSIS master module initiates the operation by setting a trigger bus signal from logic low to logic high as shown in Figure 7-12 below at point T1. This rising edge synchronizes all slave modules with output functionality to begin the setting up of the stimulus. The S_RDY signal on these modules will go to logic low.

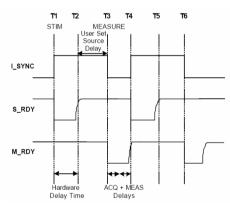


Figure 7-12 Timing Diagram for Master / Slave Operation

S_RDY will remain at logic low until all slave modules are ready to move onto the 'M' cycle. When completed these modules will release their S_RDY signal. After the last module has released the S_RDY signal, as shown in Figure 7-12 at T2, the master will detect this change and add in a user defined delay before returning to a logic '0' value as shown at T3 below. The user-defined delay is implemented to allow UUT settle time to occur.

Once each measurement capable module detects the change in the I_SYNC signal, the measure cycle will begin. Each module's M_RDY signal will go to logic '0'. This signal will remain at logic '0' while the slave modules are taking a measurement. When this has completed for each module, it will release its M_RDY signal.

After the last slave module has released the M_RDY signal, as shown in Figure 7-12 at T4, the master will detect this change and the whole process can begin again for the number of steps programmed into the test application by the user. The measurement data is loaded into a memory location for later retrieval.

During each cycle, up to 4 bytes of data are transferred either to or from memory on each module. Up to 1 million sequence steps with both output stimuli and input measurement are possible or over 500,000 sequence steps with output stimuli and two input measurements.

7.6.2 Measurement Only

The HSIS functionality can also be used to provide a series of sequenced measurement only steps without providing a stimulus.

Slave modules will assert S_RDY and M_RDY low until I_SYNC is detected high. The sequence will begin on the next rising edge of I SYNC.

The HSIS master module initiates the operation by setting a trigger bus signal from logic low to logic high as shown in Figure 7-13 below at point T1. Once each measurement capable module detects the change in the I_SYNC signal, the measure cycle will begin. Each module's M_RDY signal will go to logic '0'. This signal will remain at a logic low while the slave modules are taking a measurement. When this has completed for each module, it will release its M_RDY signal.

After the last slave module has released the M_RDY signal, as shown in Figure 7-13 at T3, the master will detect this change and the whole process can begin again for the number of steps programmed into the test application by the user. The measurement data is loaded into a memory location for later retrieval.

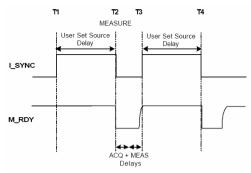


Figure 7-13 Timing Diagram for Master / Slave Operation – Measurement Only

7.7 Data Table Format

A data table is provided to store all the sequence step values. This table can contain up to 1,048,576 x 16 bit data values representing DAC output values and ADC input measurement values and other parameters.

The data table consists of a two-byte block count followed by a number of blocks which contain parameters including delay times, element count and ADC/DAC data.

Maximum block size is 64K bytes (minus 1).

Blocks are formatted in the following manner:

Element Count: 2 Byte value storing the size of the block.

Settle Time: 2 Byte value storing a user defined delay in multiples of

1.25uS or 20uS or 640mS for all steps within this block. Stim/Measure systems, this delay defines the period shown between T2 and T3 on Figure 7-12. For measuring only applications, this value defines the period during which the

I_SYNC signal will remain high.

Reserved: Two bytes value which are reserved. This space is used on

other Chroma Phontic modules.

DAC: In a Stim/Measure system, this 2 bytes memory location

which stores the value of stimulus which is output by the module (e.g. a current level). This value must be preset

before the sequencer is started.

ADC:

Two bytes memory location which stores the ADC value after a measurement has taken place.

DAC and ADC two byte pairs will be present in a block for each sequence step for that block.

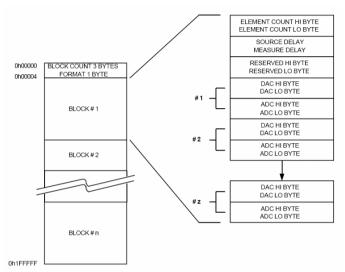


Figure 7-14 Data Table Format for Source and Measure Setup

The table format shows four bytes for each element as required for a source / measure setup. If a source or measure only setup is configured, only two bytes are required.

7.8 Front Panel Connectivity

The front panel of Chroma 52956 module has three user connectors. These are two 4mm panel sockets that are used for the main output current and a 9 pin D connector (female inserts) that is used to provide auxiliary signals.

Pins 1 and 6 provide the same current output as the two 4mm panel sockets. Pins 2 and 7 provide the voltage input for the measurement circuit. Pin 4 provides an optically isolated TTL compatible copy of the I_SYNC trigger output to allow connectivity to external devices. Pin 8 provides an optically isolated TTL compatible trigger input which can be

used by external devices to delay the generation of the I_SYNC signal on the master module.

Pin 9 provides an input used for emergency stop purpose. The module will ONLY provide a current output when the emergency stop input is connected to ground (Pin 5).

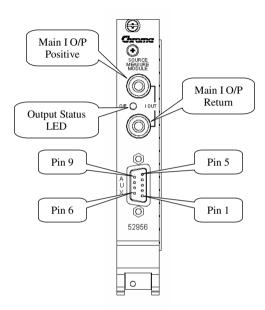


Figure 7-16 Front Panel Connector

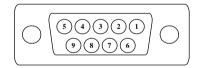


Figure 7-17 AUX Connector

Pin#	Signal Name
1	Current Output (+)
2	Voltage Input (+)
3	N/A
4	CS Trigger Out
5	Ground

6	Current Output (Return)
7	Voltage Input (-)
8	CS Trigger In
9	Emergency Stop

Table 7-1 Pin Assignment

7.9 Wire Mode

Two modes of voltage measurement are available to the user. These are 2 wires and 4 wires. In two wires mode, the voltage measurement is taken from across the output terminals and is designed to measure the voltage drop across the Unit Under Test (UUT). However, this mode also includes any voltage drop incurred by the cables connecting the UUT to the current output terminals of the module. In 4 wires mode, the measure connection to the output terminals is opened and the measurement is taken from two pins on the AUX connector. This allows the user to take the measurement at the UUT and thus eliminate any voltage drop in the cables connecting the UUT to the current output terminals.

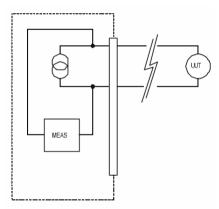


Figure 7-18 Two Wires Measurement Mode

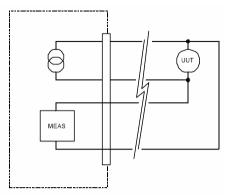


Figure 7-19 Four Wires Mode

7.10 Configuration

Chroma 52956 Module has 5 jumpers mounted on it, however only two of these are user selectable. These are JP1 and JP2. With JP1 installed, the emergency stop signal on the module can be daisy chained to the emergency stop on another module in the slot immediately to the right of the module via the right local bus 2 signal. With JP2 installed, the emergency stop signal on the module can be daisy chained to the emergency stop on another module in the slot immediately to the left of the module via the left local bus 2 lines. The module is supplied with these two jumpers installed.

Jumper JP4 is the enable / disable jumper and must be in the 'EN' position for the module to operate. Header J4 is used for programming the PIC and must have a jumper inserted onto the cross pin as shown in Figure 7-20 above. For normal operation, J11 and J3 are used for programming the PLD's. J3 must have a jumper installed in its end position for normal operation.

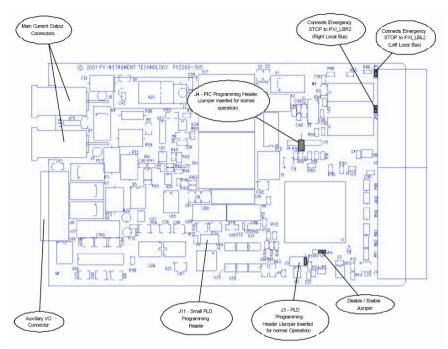


Figure 7-20 Layout of Board Showing Jumper and Connector Locations

8. Hardware Specification

Model	52956
Constant Current Source	
Current Range	50 / 500 mA
Accuracy	$\pm 0.05\% \pm 10 \mu A$ (Range: 50mA)
	$\pm 0.05\% \pm 100 \mu A$ (Range: 500mA)
Basic Resolution	16bits: 0.8μA (Range: 50mA)
	16bits: 8μA (Range: 500mA)
Compliance Voltage	0 ~ 8 V
Compliance Voltage Accuracy	$\pm 0.1\% \pm 40 \text{ mV}$
Minimal pulse width	Test condition: Range = $50mA$ Compliance Voltage = $3V$ Temperature at 25 °C $t_r t_w t_f t_f t_f = 1.8ms$ $t_r = 1.8ms t_w = 20ms t_f = 1.8ms$ Test condition: Range = $500mA$ Output current = $500mA$ Compliance Voltage = $3V$ Temperature at 25 °C $t_r t_w t_f t_f = 250us t_r = 250us$
Power Dissipation	7W
Cooling	At least 15 CFM airflow is required.
Thermal Drift	2uA/°C (Range: 50mA); 25 uA/°C (Range: 500mA)
Front panel safety interlock	2 contacts must be closed for output to be on. Multiple interlocks can be connected in parallel.
Mechanical Life	1X108MIN.Operation
DC Voltage Measurement	
Voltage Range	0 ~ ± 10 V
Accuracy	$\pm 0.1\% \pm 5 \text{ mV}$

General	
Stimuli & Measurements Rate	> 5000 per Second
Connector Interface	4mm sockets for current out. 9 pin D type for all other
Form Factor	3U PXI - single slot width
Trigger	Local Bus and Trigger Bus and front panel access
Front Panel Indication	Single LED Green indicates all OK Red indicates compliance limitation condition
Sequence Engine Specifications	
Master Clock	20Mhz
Min Step	100us
Max Step	10ms
Max Memory Blocks	100,000. Each new block describes a change in the basic sequence timing
Max steps in a single sequence	500,000
Memory	2 M byte
Standards	PXISA PXI 2.2 PICMG 2.0 R3.0 CompactPCI

All specifications are subject to change without notice.